



# Reliability Report - 54LS04

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Low power Schottky Logic - Hex Inverter Gates

## MIL-PRF-38534 CLASS K QUALIFICATION DATAPACK

Performed by Tandex Test Labs



# TANDEX

15849 Business Center Drive, Irwindale, CA 91706, U.S.A.

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[www.tandexlabs.com](http://www.tandexlabs.com)

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- Scanning Electron Microscopy (SEM) analysis.





# MIL-PRF-38534 CLASS K DATAPACK

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## Certificate of Conformance



# TANDEX TEST LABS, INC.

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e-mail: via web site

## Certificate of Conformance

<b>CUSTOMER:</b>	<b>SILICON SUPPLIES LIMITED</b>	<b>DATE:</b> November 2, 2018
	47 WHERRY ROAD NORWICH, NR1, 1WS UNITED KINGDOM VAT GB#114 3513 56	
<b>TEST REPORT:</b>	<b>DDS-101-14-A</b>	<b>QUANTITY RECEIVED:</b> 30+25 DIE
<b>P.O. NUMBER:</b>	<b>SS139</b>	<b>QUANTITY REQUIRED:</b> 10/5/8
<b>DESCRIPTION:</b>	<b>SCHOTTKY LOGIC MICROCIRCUIT</b>	<b>QUANTITY PROCESSED:</b> 17
<b>PART NUMBER(S):</b>	<b>54LS04</b>	<b>QUANTITY PASSED:</b> 17
<b>P/N: AS RECEIVED / MFG. PART NUMBER:</b>	<b>54LS04</b>	<b>QUANTITY FAILED:</b> 0
<b>LOT / DATE CODE:</b>	<b>1810 LOT# 700654 WF 11</b>	
<b>MANUFACTURE: CAGE CODE:</b>	<b>SILICON SUPPLIES</b>	<b>QUANTITY SHIPPING:</b> 17*
		INCLUDES: 10 PROCESS ACCEPT 5 BOND PULL DEVICES 2 SPARE
<b>TANDEX CAGE CODE:</b>	<b>1FE65</b>	*8 DIE TRANSFERRED TO DDS-101-14-W FOR SEM.

**METHOD OF TESTING: MIL-PRF-38534 CL. K, MIL-STD-883**

I hereby certify that the subject components have been processed and inspected in accordance with instructions with specifications referenced in your purchase order. Physical records and/or data pertinent to applicable military, proprietary, and/or commercial specifications are on file and available upon request for inspection at this facility.

Linda S. Sepulveda  
QUALITY ASSURANCE

QMF 30



# MIL-PRF-38534 CLASS K DATAPACK

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Process Flow Chart + Mechanical Test Results



# TANDEX TEST LABS INC.

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15849 BUSINESS CENTER DRIVE, IRWINDALE, CA. 91706 PH: (626)962-7166 FAX: (626) 960-6896

## PROCESS FLOW CHART

FLOW NUMBER: DDS-101-14-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139  
 PART NUMBER: 54LS04 P/N AS RECEIVED: 54LS04  
 PART TYPE: SCHOTTKY LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883  
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-14-A  
 LDC AS RECEIVED: 1810 LOT# 700654 WF11 QUANTITY RECEIVED: 30 (DIE)  
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED: 10/5/8 + 25 NEW DIE

**\*CAUTION: ESD REFER TO TTL DRAWING #P1025\***

01	FLO	P-1015 P-1223	FLOW PREPARED BY: <u>LSS</u> ON: <u>3/29/18</u> . CONTRACTUAL AGREEMENT REVIEW Y N NOT SPECIFIED <input type="checkbox"/> <input checked="" type="checkbox"/> <input checked="" type="checkbox"/> Q-CLAUSES <input type="checkbox"/> <input checked="" type="checkbox"/> <input type="checkbox"/> DPAS <input type="checkbox"/> <input checked="" type="checkbox"/> <input type="checkbox"/> DFAR <input type="checkbox"/> <input checked="" type="checkbox"/> <input type="checkbox"/> ITAR <input type="checkbox"/> <input type="checkbox"/> OTHER SPECIFIED							
02	QCI		TANDEX QUALITY CONTROL INSPECTION. FLOW APPROVED BY: <u>JMI</u> ON: <u>3/29/18</u> .							
03	RCV	P-1070	VERIFY PART NUMBER. ENTER INTO INCOMING LOG. <u>X</u> CUSTOMER COUNT 6/18/18	30 +25			3/29/18			
SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEPT	DATE	INSP.		
04	VIS	P-1041	PERFORM 100% DIE VISUAL PER MIL-STD-883 METHOD 2010 AND MIL-PRF-38534 PARA C.3.3.2. EQUIPMENT USED: <u>Olympus</u> ASSET #: <u>20091</u>	25 30	0	25 30	6/18/18	TTL 4		
05	ASSY	P-1029	PACKAGE SUFFICIENT DEVICES FOR CLASS K ELEMENT EVALUATION / ELECTRICAL AND BOND PULL PER MIL-PRF-38534 REFERENCE DIE GEOMETRY FOR ORIENTATION AND PIN - OUTS. DIE ATTACH: SCREENING EUTETIC BOND PULL Lot#: <u>149555</u> Exp. Date: <u>NA</u> SEM * Package Type: 14 PIN DIP TRANSFER TO DDS-101-14-W MIL-STD-883 METHOD 2018	10+2 5 8	0 0 0	10+2 5 8	6/18/18 6/18/18 6/18/18	TTL 27 TTL 27 TTL 4		
		P-4010	WIRE BOND: Utilize 1 Mil Au Wire (.001) 1 Mil Au bonder <u>Mech-el</u> Asset #: <u>20060</u> Gold Wire: <u>900301960</u> Lot#: _____ Exp. Date: <u>3/14/20</u>	17	0	17	6/19/18	TTL 27		

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## PROCESS FLOW CHART

FLOW NUMBER: DDS-101-14-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139  
 PART NUMBER: 54LS04 P/N AS RECEIVED: 54LS04  
 PART TYPE: SCHOTTKY LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883  
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-14-A  
 LDC AS RECEIVED: 1810 LOT# 700654 WF11 QUANTITY RECEIVED: 30 (DIE)  
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED: 10/5/8

**\*CAUTION: ESD REFER TO TTL DRAWING #P1025\***

SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEPT	DATE	INSP.
06	VIS		PERFORM 100% INTERNAL VISUAL PER MIL-STD-883 METHOD 2010 & MIL-PRF-38534 C.3.3.3, C.3.3.4.2.  EQUIPMENT USED: <u>Baush Lomb</u> ASSET #: <u>30772</u>	17	0	17	6/19/18	TTL 27
			ESD MAT DUE DATE: <u>6/27/18</u>					
07	SEAL		SEAL DEVICES  VACUUM BAKE: Pre Seal Bake Time: Temp: <u>125°C</u> Time: <u>24hrs</u> Actual time in: <u>12:00 PM 6/19/18</u> Actual time out: <u>12:10 PM 6/20/18</u> FURNACE LDC STAMP Actual temp: <u>125°C</u>  <u>1824</u> 	10+2	0	10+2	6/20/18	TTL 30
			ESD MAT DUE DATE: <u>6/27/18</u>					
08	ELEC		PERFORM 100% ELECTRICAL VERIFICATION TEST PER MFG DATA SHEET AND MIL-PRF-38534 @ AMBIENT OPERATING TEMPERATURE GO / NO GO  EQUIPMENT USED: <u>Sonday</u> ASSET #: <u>1093</u> +25°C TEST FIXTURE: <u>1377/1207</u> SOFTWARE ID: <u>54LS04 REV N/A</u>	10+2	0	10+2	7/16/18	
			ESD MAT DUE DATE: <u>7/27/18</u>					
09	TEMP		PERFORM TEMPERATURE CYCLING PER MIL-STD-883 METHOD 1010 CONDITION C & MIL-PRF-38534 C.3.3.3.  TEN (10) CYCLES DATE IN TIME IN TA = -65°C +0/-10 to +150°C +15/-0  10 MINUTES AT EXTREMES DATE OUT TIME OUT  EQUIPMENT USED: <u>DELTA DESIGN</u> ASSET #: <u>30626</u> EQUIPMENT USED: <u>OMEGA HH309A</u> ASSET #: <u>31567</u>	10+2	0	10+2	7/25/18 5:16 A.M.	TTL 48
			ESD MAT DUE DATE: <u>7/27/18</u>					
10	ACCE		PERFORM CONSTANT ACCELERATION PER MIL-PRF-38534 MIL-STD-883 METHOD 2001.  Y1 DIRECTION ONLY @ 3000 G's (min)  EQUIPMENT USED: <u>TRIOtach</u> ASSET #: <u>302600</u>	10+2	0	10+2	7/26/18	TTL 52
			ESD MAT DUE DATE: <u>7/27/18</u>					
11	SER		SERIALIZE  <u>01-12</u> S/N: <u>0110</u> 	10+2	0	10+2	7/31/18	TTL 40
			ESD MAT DUE DATE: <u>8/27/18</u>					

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## PROCESS FLOW CHART

FLOW NUMBER: DDS-101-14-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139  
 PART NUMBER: 54LS04 P/N AS RECEIVED: 54LS04  
 PART TYPE: SCHOTTKY LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883  
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-14-A  
 LDC AS RECEIVED: 1810 LOT# 700654 WF11 QUANTITY RECEIVED: 30 (DIE)  
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED: 10/5/8

**\*CAUTION: ESD REFER TO TTL DRAWING #P1025\***

SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEP	DATE	INSP.
12	ELEC		PERFORM 100% ELECTRICAL VERIFICATION PER MFG DATA SHEET3 AND MIL-PRF-38534 C.3.3.4.3 @ AMBIENT , HIGH AND LOW OPERATING TEMPERATURES. READ AND RECORD.  STATIC AND FUNCTIONAL TESTS +25°C 12 $\emptyset$ 12 8/11/18 <i>CTH</i> -55°C 12 $\emptyset$ 12 8/11/18 <i>CCU</i> +125°C 12 $\emptyset$ 12 8/11/18 <i>CTH</i>  EQUIPMENT USED: <i>Sentry</i> ASSET#: <i>1093</i> TEST FIXTURE: <i>1377/1201</i> SOFTWARE ID: <i>54LS04 REV N/A</i> TEMPERATURE SOAK <i>10</i> SEC.					
			ESD MAT DUE DATE: 8/27/18.					
13	BI		PERFORM BURN IN PER BURN IN CIRCUIT PER FIGURE 1 OF DWG# 1026-16668, AND MIL-STD 883 METHOD 1015.  TA = 125°C (min) DATE IN: 12 $\emptyset$ 12 8/9/18 T = 240 HRS (min) TIME IN: 6:30AM <b>TTL 13</b>  BURN-IN BOARD # / DESC: <i>31270</i> DATE OUT: 12 $\emptyset$ 12 8/20/18 BURN-IN OVEN #: <i>21</i> TIME OUT: 5:45AM <b>TTL 13</b>					
			ESD MAT DUE DATE: 8/27/18.					
14	ELEC		PERFORM POST BURN IN ELECTRICAL VERIFICATION PER MFG DATA SHEET AND MIL-PRF-38534 C.3.3.4.3 @ AMBIENT, HIGH AND LOW OPERATING TEMPERATURES. READ AND RECORD.  STATIC AND FUNCTIONAL TESTS +25°C 12 $\emptyset$ 12 8/29/18 <b>TTL 10</b> -55°C 12 $\emptyset$ 12 8/29/18 <b>TTL 10</b> +125°C 12 $\emptyset$ 12 8/29/18 <b>TTL 10</b>  TEST +25°C WITHIN 96 HOURS  EQUIPMENT USED: <i>Sentry</i> ASSET#: <i>1093</i> TEST FIXTURE: <i>1377/1201</i> SOFTWARE ID: <i>54LS04 REV N/A</i> TEMPERATURE SOAK <i>10</i> SEC.					
			ESD MAT DUE DATE: 8/27/18.					
15	ER		PER PO REQUIREMENTS: REVIEW AT POST 240 HR. BURN-IN  EMAIL: <a href="mailto:ben.white@diodevices.com">ben.white@diodevices.com</a> POST 240 HR BURN-IN ELECTRICAL TEST DATA. HOLD FOR APPROVAL TO PROCEED  DATE SENT: <i>8/29/18</i>					8/30/18 <b>QA TANDEX 5</b>

TANDEX TEST LABS  
 BURN - IN MONITOR SHEET

PAGE 1 OF 1

JOB NUMBER DDS-101-14-A

TEMPERATURE J<sub>A</sub> = 125°C Min

PART NUMBER 54LS04

TEMP. METER # 31368

DATE CODE 1810 LOT# 700654 WF11

VOLTAGE V<sub>CC</sub> = +5V<sub>DC</sub>

BURN-IN TIME 240 hrs Min

VOLT METER# 31223

θ<sub>JC</sub> = N/A

POWER SUPPLY# 30721

BOARD# 31270

OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
8/9/18	6:30AM	V <sub>CC</sub> = +5V <sub>DC</sub>	I <sub>CC</sub> = .05A	126.0°C	CM	
8/10/18	6:45AM	V <sub>CC</sub> = +5V <sub>DC</sub>	I <sub>CC</sub> = .05A	125.7°C	CM	
8/13/18	5:40AM	V <sub>CC</sub> = +5V <sub>DC</sub>	I <sub>CC</sub> = .05A	125.6°C	CM	
8/14/18	NO	DATA	TAKEN			
8/15/18	NO	DATA	TAKEN			
8/16/18	6:05AM	V <sub>CC</sub> = +5V <sub>DC</sub>	I <sub>CC</sub> = .05A	126.1°C	CM	
8/17/18	9:35AM	V <sub>CC</sub> = +5V <sub>DC</sub>	I <sub>CC</sub> = .05A	126.1°C	CM	
8/20/18	5:45AM	V <sub>CC</sub> = +5V <sub>DC</sub>	I <sub>CC</sub> = .05A	126.1°C	CM	



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## PROCESS FLOW CHART

FLOW NUMBER: DDS-101-14-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139  
 PART NUMBER: 54LS04 P/N AS RECEIVED: 54LS04  
 PART TYPE: SCHOTTKY LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883  
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-14-A  
 LDC AS RECEIVED: 1810 LOT# 700654 WF11 QUANTITY RECEIVED : 30 (DIE)  
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED : 10/5/8

**\*CAUTION: ESD REFER TO TTL DRAWING #P1025\***

SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEPT	DATE	INSP.
16	SSL		PERFORM STEADY STATE LIFE TEST PER MIL-PRF-38534 AND MIL-STD 883 METHOD 1005.  TA = 125°C (min) T = 1000 HRS (min)  DATE IN: 9/4/18 TIME IN: 8:00AM  DATE OUT: 10/16/18 TIME OUT: 5:30AM  BURN-IN BOARD # / DESC: <u>31270</u> BURN-IN OVEN #: <u>21</u>	12	0	12		TTL 13
ESD MAT DUE DATE: <u>10/22/18</u>								
17	ELEC		PERFORM POST STEADY STATE LIFE ELECTRICAL VERIFICATION PER MFG DATA SHEET AND MIL-PRF-38534 C.3.3.4.3. @ AMBIENT, HIGH AND LOW OPERATING TEMPERATURE. READ AND RECORD.  STATIC AND FUNCTIONAL TESTS +25°C 12 0 12 10/16/18 -55°C 12 0 12 10/16/18 +125°C 12 0 12 10/16/18  TEST +25°C WITHIN 96 HOURS  EQUIPMENT USED: <u>Sentry 1</u> ASSET#: <u>1093</u> TEST FIXTURE: <u>1377/1201</u> SOFTWARE ID: _____ REV _____	12	0	12		TTL 27
ESD MAT DUE DATE: <u>10/27/18</u>								
18	DBP		PERFORM WIRE BOND PULL PER MIL-STD-883 METHOD 2011, & MIL-PRF-38534 C.3.3.3, C3.3.5.  TEN ( 10 ) WIRES,  *DO NOT USE ELECTRICAL TEST SAMPLES*  EQUIPMENT USED: <u>DAGE</u> ASSET #: <u>30785</u>	5	0	5	9/11/18	#4 QA TANDEX 5
19	SEM		PULLED 8 DEVICES AT SEQ. 05 AND TRANSFERRED TO:  DDS-101-14-W	8	0	0	11/1/18	QA TANDEX 5

TANDEX TEST LABS  
 BURN - IN MONITOR SHEET

PAGE 1 OF 4

JOB NUMBER DDS-101-14-A  
 PART NUMBER 54LS04  
 DATE CODE 1810 LOT# 700654 WF11  
 BURN-IN TIME 1000 hrs Min  
 ΘJC= N/A

TEMPERATURE TA = +125°C Min  
 TEMP. METER# 31368  
 VOLTAGE VCC = +5VDC  
 VOLT METER# 31223  
 POWER SUPPLY# 30721  
 BOARD# 31270  
 OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
9/4/18	8:00AM	VCC = +5VDC	ICC = .05A	126.5°C	CM	
9/5/18	7:30AM	VCC = +5VDC	ICC = .05A	125.5°C	CM	
9/6/18	10:00AM	VCC = +5VDC	ICC = .05A	126.0°C	CM	
9/7/18	5:50AM	VCC = +5VDC	ICC = .05A	126.6°C	CM	
9/10/18	7:00AM	VCC = +5VDC	ICC = .05A	126.2°C	CM	
9/11/18	6:00AM	VCC = +5VDC	ICC = .05A	126.0°C	CM	
9/12/18	NO	DATA	TAKEN			
9/13/18	9:05AM	VCC = +5VDC	ICC = .05A	125.8°C	CM	
9/14/18	8:55AM	VCC = +5VDC	ICC = .05A	126.5°C	CM	

TANDEX TEST LABS  
 BURN - IN MONITOR SHEET

JOB NUMBER DDS-101-14-A  
 PART NUMBER 54LS04  
 DATE CODE 1810 LOT# 700654 WFI1  
 BURN-IN TIME 1000hrs Min  
 ΘJC= N/A

TEMPERATURE TA = +125°C Min  
 TEMP. METER # 31368  
 VOLTAGE VCC = +5VDC  
 VOLT METER# 31223  
 POWER SUPPLY# 30721  
 BOARD# 31270  
 OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
9/17/18	8:00AM	VCC = +5VDC	ICC = .05A	126.4°C	CM	
9/18/18	5:50AM	VCC = +5VDC	ICC = .05A	126.6°C	CM	
9/19/18	5:30AM	VCC = +5VDC	ICC = .05A	126.2°C	CM	
9/20/18	7:30AM	VCC = +5VDC	ICC = .05A	126.3°C	CM	
9/21/18	NO	DATA	TAKEN			
9/24/18	NO	DATA	TAKEN			
9/25/18	5:30AM	VCC = +5VDC	ICC = .05A	126.2°C	CM	
9/26/18	6:00AM	VCC = +5VDC	ICC = .05A	126.3°C	CM	
9/27/18	6:30AM	VCC = +5VDC	ICC = .05A	126.7°C	CM	
9/28/18	6:50AM	VCC = +5VDC	ICC = .05A	127.2°C	CM	

TANDEX TEST LABS  
 BURN - IN MONITOR SHEET

JOB NUMBER DDS-101-14-A  
 PART NUMBER 54LS04  
 DATE CODE 1810 LOT# 700654 WFL1  
 BURN-IN TIME 1000 hrs Min  
 ΘJC= N/A

TEMPERATURE TA = +125°C Min  
 TEMP. METER # 31368  
 VOLTAGE VCC = +5VDC  
 VOLT METER# 31223  
 POWER SUPPLY# 30721  
 BOARD# 31270  
 OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
10/1/18	6:00 AM	VCC = +5VDC	ICC = .05A	127.7°C	CM	
10/2/18	8:40 AM	VCC = +5VDC	ICC = .05A	124.6°C	CM	
10/3/18	7:30 AM	VCC = +5VDC	ICC = .05A	127.4°C	CM	
10/4/18	7:00 AM	VCC = +5VDC	ICC = .05A	125.5°C	CM	
10/5/18	6:00 AM	VCC = +5VDC	ICC = .05A	127.6°C	CM	
10/8/18	5:30 AM	VCC = +5VDC	ICC = .05A	127.1°C	CM	
10/9/18	NO DATA TAKEN					
10/10/18	6:00 AM	VCC = +5VDC	ICC = .05A	126.8°C	CM	
10/17/18	5:30 AM	VCC = +5VDC	ICC = .05A	127.4°C	CM	
10/12/18	5:10 AM	VCC = +5VDC	ICC = .05A	126.4°C	CM	

TANDEX TEST LABS  
 BURN - IN MONITOR SHEET

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JOB NUMBER DDS-101-14-A

TEMPERATURE TA = +125°C Min

PART NUMBER 54LS04

TEMP. METER# 31368

DATE CODE 1810 LOT# 700654 WFI1

VOLTAGE VCC = +5VDC

BURN-IN TIME 1000hrs Min

VOLT METER# 31223

ΘJC = N/A

POWER SUPPLY# 30721

BOARD# 31270

OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
<u>10/15/18</u>	<u>6:10AM</u>	<u>VCC = +5VDC</u>	<u>ICC = .05A</u>	<u>127.0°C</u>	<u>CM</u>	
<u>10/16/18</u>	<u>5:30AM</u>	<u>VCC = +5VDC</u>	<u>ICC = .05A</u>	<u>127.4°C</u>	<u>CM</u>	

**BOND PULL****BOND STRENGTH TESTING**

TTL Job No. DDS-101-14-A	Part Number 54LS04	Part Type SCHOTTKY LOGIC MI-CROCIRCUIT	Date September 11, 2018
Lot Date Code LOT# 700654 W# 11 1810	Sample Qty. 5	Serial Numbers 11-15	Test Specifications Mil-Std-883 Method 2011
Misc.	Qty Accept 5	Qty Reject 0	Suspect 0

WIRE TYPE Au	PACKAGE/POST Au	BOND TYPE BALL BOND
DIE METALIZATION Al	WIRE SIZE 0.001	MINIMUM PULL STRENGTH 2.5gm

S/N 11			S/N 12			S/N 13			S/N 14			S/N 15			S/N		
WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE
1	4.0	G	1	4.0	G	1	5.0	G	1	4.5	G	1	4.5	G	1		
2	4.5	G	2	4.5	G	2	4.0	E	2	5.0	G	2	3.0	G	2		
3			3			3			3			3			3		
4			4			4			4			4			4		
5			5			5			5			5			5		

## CODE INDEX

- A. NO BREAKS UP TO \_\_\_\_\_gms.
- B. BOND LIFTS FROM DIE.
- C. BOND LIFTS FROM POST.
- D. WIRE BREAKS AT SUBSTRATE/HEAL.
- E. BOND REMOVES UNDERLYING METALLIZATION.
- F. NO CONNECTION.
- G. WIRE BREAKS AT DIE/HEAL.
- H. WIRE BREAKS AT POST/HEAL.
- J. WIRE BREAKS AT SPAN.
- X. BOND DAMAGE PRIOR TO TESTING.



TECHNICIAN STAMP:

# TANDEX TEST LABS INC.

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## PROCESS FLOW CHART

FLOW NUMBER: DDS-101-14-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139  
 PART NUMBER: 54LS04 P/N AS RECEIVED: 54LS04  
 PART TYPE: SCHOTTKY LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883  
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-14-A  
 LDC AS RECEIVED: 1810 LOT# 700654 WF11 QUANTITY RECEIVED: 30 (DIE)  
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED: 10/5/8

**\*CAUTION: ESD REFER TO TTL DRAWING #P1025\***

SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEPT	DATE	INSP.
20	QCI	P-1073	TANDEX QUALITY CONTROL INSPECTION.  QCI TO VERIFY CAR IN SEQ. 01 IS COMPLIANT	17	Ø	17	11/2/18	QA TANDEX 5
21	PKG		USE ORIGINAL OR TANDEX PACKAGING.	17	Ø	17	11/2/18	QA TANDEX 5
22	QAR	P-1213	TANDEX QUALITY ASSURANCE REVIEW.  SHIP VIA:  SHIP / BILL TO: DIE DEVICES 47 WHERRY ROAD NORWICH, NRI, IWS UNITED KINGDOM VAT GB#114 3513 56  * INCLUDES 10 ACCEPT 5 BOND PULL 2 SPARE S  ** 8 TRANSFERRED TO DDS-101-14 - W FOR SEM	* 17			11/2/18	QA TANDEX 5



# MIL-PRF-38534 CLASS K DATAPACK

---

Pre Burn-In Test Results at -55°C





STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 1  
DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-540.0MV	-1.500 V	-100.0MV
58	3	-540.0MV	-1.500 V	-100.0MV
58	5	-540.0MV	-1.500 V	-100.0MV
58	9	-540.0MV	-1.500 V	-100.0MV
58	11	-540.0MV	-1.500 V	-100.0MV
58	13	-1.020 V	-1.500 V	-100.0MV
58	14	-630.0MV	-1.500 V	-100.0MV
58	2	-690.0MV	-1.500 V	-100.0MV
58	4	-690.0MV	-1.500 V	-100.0MV
58	6	-690.0MV	-1.500 V	-100.0MV
58	8	-690.0MV	-1.500 V	-100.0MV
58	10	-690.0MV	-1.500 V	-100.0MV
58	12	-690.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.260 V	-1.500 V	
85	3	-1.060 V	-1.500 V	
91	5	-1.060 V	-1.500 V	
97	9	-960.0MV	-1.500 V	
103	11	-1.010 V	-1.500 V	
109	13	-1.210 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.830 V	2.500 V	
200	4	2.840 V	2.500 V	
206	6	2.830 V	2.500 V	
212	8	2.840 V	2.500 V	
218	10	2.830 V	2.500 V	
224	12	2.830 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	348.0MV		400.0MV
250	4	286.0MV		400.0MV
256	6	292.0MV		400.0MV
262	8	298.0MV		400.0MV
268	10	304.0MV		400.0MV
274	12	310.0MV		400.0MV

-----

FUNCTIONAL TEST  
VCC= 5.500  
VIH= 2 VIL= 700.0E-03

---

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.10MA	-100.0MA	-20.00MA
306	4	-48.70MA	-100.0MA	-20.00MA
312	6	-47.80MA	-100.0MA	-20.00MA
318	8	-46.30MA	-100.0MA	-20.00MA
324	10	-45.20MA	-100.0MA	-20.00MA
330	12	-45.30MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-240.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-240.0UA	-400.0UA	
425	9	-240.0UA	-400.0UA	
429	11	-240.0UA	-400.0UA	
433	13	-240.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.640MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	5.060MA		6.600MA

EIR 1.....10 FCT DCT  
0000000000 PASS PASS EOT

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 2

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-540.0MV	-1.500 V	-100.0MV
58	3	-540.0MV	-1.500 V	-100.0MV
58	5	-530.0MV	-1.500 V	-100.0MV
58	9	-540.0MV	-1.500 V	-100.0MV
58	11	-540.0MV	-1.500 V	-100.0MV
58	13	-540.0MV	-1.500 V	-100.0MV
58	14	-630.0MV	-1.500 V	-100.0MV
58	2	-690.0MV	-1.500 V	-100.0MV
58	4	-690.0MV	-1.500 V	-100.0MV
58	6	-690.0MV	-1.500 V	-100.0MV
58	8	-690.0MV	-1.500 V	-100.0MV
58	10	-690.0MV	-1.500 V	-100.0MV
58	12	-700.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.220 V	-1.500 V	
85	3	-960.0MV	-1.500 V	
91	5	-1.010 V	-1.500 V	
97	9	-940.0MV	-1.500 V	
103	11	-980.0MV	-1.500 V	
109	13	-1.230 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.820 V	2.500 V	
200	4	2.830 V	2.500 V	
206	6	2.820 V	2.500 V	
212	8	2.830 V	2.500 V	
218	10	2.830 V	2.500 V	
224	12	2.820 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	302.0MV		400.0MV
250	4	274.0MV		400.0MV
256	6	280.0MV		400.0MV
262	8	296.0MV		400.0MV
268	10	286.0MV		400.0MV
274	12	332.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.10MA	-100.0MA	-20.00MA
306	4	-48.40MA	-100.0MA	-20.00MA
312	6	-47.30MA	-100.0MA	-20.00MA
318	8	-45.60MA	-100.0MA	-20.00MA
324	10	-45.10MA	-100.0MA	-20.00MA
330	12	-45.40MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	0 A		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	300.0NA		100.0UA
381	3	100.0NA		100.0UA
385	5	0 A		100.0UA
389	9	0 A		100.0UA
393	11	-100.0NA		100.0UA
397	13	0 A		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-240.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-230.0UA	-400.0UA	
425	9	-230.0UA	-400.0UA	
429	11	-240.0UA	-400.0UA	
433	13	-240.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.630MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.980MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 3

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-550.0MV	-1.500 V	-100.0MV
58	3	-550.0MV	-1.500 V	-100.0MV
58	5	-550.0MV	-1.500 V	-100.0MV
58	9	-550.0MV	-1.500 V	-100.0MV
58	11	-550.0MV	-1.500 V	-100.0MV
58	13	-550.0MV	-1.500 V	-100.0MV
58	14	-650.0MV	-1.500 V	-100.0MV
58	2	-700.0MV	-1.500 V	-100.0MV
58	4	-700.0MV	-1.500 V	-100.0MV
58	6	-710.0MV	-1.500 V	-100.0MV
58	8	-710.0MV	-1.500 V	-100.0MV
58	10	-710.0MV	-1.500 V	-100.0MV
58	12	-710.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.230 V	-1.500 V	
85	3	-970.0MV	-1.500 V	
91	5	-1.020 V	-1.500 V	
97	9	-940.0MV	-1.500 V	
103	11	- 1 V	-1.500 V	
109	13	-1.020 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.810 V	2.500 V	
200	4	2.810 V	2.500 V	
206	6	2.810 V	2.500 V	
212	8	2.810 V	2.500 V	
218	10	2.810 V	2.500 V	
224	12	2.800 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	304.0MV		400.0MV
250	4	272.0MV		400.0MV
256	6	278.0MV		400.0MV
262	8	284.0MV		400.0MV
268	10	284.0MV		400.0MV
274	12	332.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.90MA	-100.0MA	-20.00MA
306	4	-49.30MA	-100.0MA	-20.00MA
312	6	-48.60MA	-100.0MA	-20.00MA
318	8	-47.50MA	-100.0MA	-20.00MA
324	10	-46.60MA	-100.0MA	-20.00MA
330	12	-46.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	100.0NA		20.00UA
350	3	0 A		20.00UA
354	5	0 A		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	600.0NA		100.0UA
381	3	500.0NA		100.0UA
385	5	0 A		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-240.0UA	-400.0UA	
417	3	-250.0UA	-400.0UA	
421	5	-240.0UA	-400.0UA	
425	9	-240.0UA	-400.0UA	
429	11	-240.0UA	-400.0UA	
433	13	-240.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.690MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	5.170MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 4

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-530.0MV	-1.500 V	-100.0MV
58	3	-530.0MV	-1.500 V	-100.0MV
58	5	-530.0MV	-1.500 V	-100.0MV
58	9	-530.0MV	-1.500 V	-100.0MV
58	11	-530.0MV	-1.500 V	-100.0MV
58	13	-530.0MV	-1.500 V	-100.0MV
58	14	-620.0MV	-1.500 V	-100.0MV
58	2	-680.0MV	-1.500 V	-100.0MV
58	4	-680.0MV	-1.500 V	-100.0MV
58	6	-680.0MV	-1.500 V	-100.0MV
58	8	-680.0MV	-1.500 V	-100.0MV
58	10	-680.0MV	-1.500 V	-100.0MV
58	12	-690.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.230 V	-1.500 V	
85	3	-960.0MV	-1.500 V	
91	5	-1.010 V	-1.500 V	
97	9	-930.0MV	-1.500 V	
103	11	-990.0MV	-1.500 V	
109	13	-1.020 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.840 V	2.500 V	
200	4	2.840 V	2.500 V	
206	6	2.840 V	2.500 V	
212	8	2.840 V	2.500 V	
218	10	2.840 V	2.500 V	
224	12	2.840 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	300.0MV		400.0MV
250	4	268.0MV		400.0MV
256	6	272.0MV		400.0MV
262	8	276.0MV		400.0MV
268	10	280.0MV		400.0MV
274	12	308.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.60MA	-100.0MA	-20.00MA
306	4	-49.00MA	-100.0MA	-20.00MA
312	6	-48.20MA	-100.0MA	-20.00MA
318	8	-47.30MA	-100.0MA	-20.00MA
324	10	-46.20MA	-100.0MA	-20.00MA
330	12	-45.60MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	1.200UA		20.00UA
350	3	0 A		20.00UA
354	5	0 A		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	3.200UA		100.0UA
381	3	4.900UA		100.0UA
385	5	400.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-240.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-240.0UA	-400.0UA	
425	9	-240.0UA	-400.0UA	
429	11	-240.0UA	-400.0UA	
433	13	-240.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.670MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	5.110MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```



STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 5

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-520.0MV	-1.500 V	-100.0MV
58	3	-530.0MV	-1.500 V	-100.0MV
58	5	-530.0MV	-1.500 V	-100.0MV
58	9	-530.0MV	-1.500 V	-100.0MV
58	11	-530.0MV	-1.500 V	-100.0MV
58	13	-530.0MV	-1.500 V	-100.0MV
58	14	-610.0MV	-1.500 V	-100.0MV
58	2	-680.0MV	-1.500 V	-100.0MV
58	4	-680.0MV	-1.500 V	-100.0MV
58	6	-680.0MV	-1.500 V	-100.0MV
58	8	-680.0MV	-1.500 V	-100.0MV
58	10	-680.0MV	-1.500 V	-100.0MV
58	12	-680.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.300 V	-1.500 V	
85	3	-960.0MV	-1.500 V	
91	5	-1.020 V	-1.500 V	
97	9	-930.0MV	-1.500 V	
103	11	- 1 V	-1.500 V	
109	13	-1.030 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.850 V	2.500 V	
200	4	2.850 V	2.500 V	
206	6	2.850 V	2.500 V	
212	8	2.850 V	2.500 V	
218	10	2.850 V	2.500 V	
224	12	2.840 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	302.0MV		400.0MV
250	4	270.0MV		400.0MV
256	6	274.0MV		400.0MV
262	8	280.0MV		400.0MV
268	10	286.0MV		400.0MV
274	12	332.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.30MA	-100.0MA	-20.00MA
306	4	-48.70MA	-100.0MA	-20.00MA
312	6	-47.90MA	-100.0MA	-20.00MA
318	8	-47.00MA	-100.0MA	-20.00MA
324	10	-45.80MA	-100.0MA	-20.00MA
330	12	-45.20MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	1.100UA		20.00UA
350	3	6.100UA		20.00UA
354	5	0 A		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	3.200UA		100.0UA
381	3	22.90UA		100.0UA
385	5	300.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-240.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-240.0UA	-400.0UA	
425	9	-240.0UA	-400.0UA	
429	11	-240.0UA	-400.0UA	
433	13	-240.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.660MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	5.060MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 6

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-530.0MV	-1.500 V	-100.0MV
58	3	-530.0MV	-1.500 V	-100.0MV
58	5	-530.0MV	-1.500 V	-100.0MV
58	9	-530.0MV	-1.500 V	-100.0MV
58	11	-530.0MV	-1.500 V	-100.0MV
58	13	-530.0MV	-1.500 V	-100.0MV
58	14	-610.0MV	-1.500 V	-100.0MV
58	2	-680.0MV	-1.500 V	-100.0MV
58	4	-680.0MV	-1.500 V	-100.0MV
58	6	-680.0MV	-1.500 V	-100.0MV
58	8	-680.0MV	-1.500 V	-100.0MV
58	10	-680.0MV	-1.500 V	-100.0MV
58	12	-680.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.220 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-1.010 V	-1.500 V	
97	9	-930.0MV	-1.500 V	
103	11	-990.0MV	-1.500 V	
109	13	-1.040 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.850 V	2.500 V	
200	4	2.850 V	2.500 V	
206	6	2.850 V	2.500 V	
212	8	2.850 V	2.500 V	
218	10	2.850 V	2.500 V	
224	12	2.850 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	300.0MV		400.0MV
250	4	268.0MV		400.0MV
256	6	272.0MV		400.0MV
262	8	284.0MV		400.0MV
268	10	282.0MV		400.0MV
274	12	290.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.10MA	-100.0MA	-20.00MA
306	4	-48.50MA	-100.0MA	-20.00MA
312	6	-47.80MA	-100.0MA	-20.00MA
318	8	-46.00MA	-100.0MA	-20.00MA
324	10	-45.60MA	-100.0MA	-20.00MA
330	12	-44.20MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	1.100UA		20.00UA
350	3	7.600UA		20.00UA
354	5	100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	3.000UA		100.0UA
381	3	27.20UA		100.0UA
385	5	1.900UA		100.0UA
389	9	0 A		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-230.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-230.0UA	-400.0UA	
425	9	-230.0UA	-400.0UA	
429	11	-230.0UA	-400.0UA	
433	13	-230.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.630MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.950MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 7

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-520.0MV	-1.500 V	-100.0MV
58	3	-520.0MV	-1.500 V	-100.0MV
58	5	-520.0MV	-1.500 V	-100.0MV
58	9	-520.0MV	-1.500 V	-100.0MV
58	11	-530.0MV	-1.500 V	-100.0MV
58	13	-530.0MV	-1.500 V	-100.0MV
58	14	-610.0MV	-1.500 V	-100.0MV
58	2	-670.0MV	-1.500 V	-100.0MV
58	4	-670.0MV	-1.500 V	-100.0MV
58	6	-670.0MV	-1.500 V	-100.0MV
58	8	-680.0MV	-1.500 V	-100.0MV
58	10	-680.0MV	-1.500 V	-100.0MV
58	12	-680.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.210 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-1.010 V	-1.500 V	
97	9	-930.0MV	-1.500 V	
103	11	-990.0MV	-1.500 V	
109	13	-1.200 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.850 V	2.500 V	
200	4	2.850 V	2.500 V	
206	6	2.850 V	2.500 V	
212	8	2.850 V	2.500 V	
218	10	2.850 V	2.500 V	
224	12	2.840 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	296.0MV		400.0MV
250	4	266.0MV		400.0MV
256	6	268.0MV		400.0MV
262	8	284.0MV		400.0MV
268	10	280.0MV		400.0MV
274	12	292.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.50MA	-100.0MA	-20.00MA
306	4	-48.70MA	-100.0MA	-20.00MA
312	6	-48.00MA	-100.0MA	-20.00MA
318	8	-46.20MA	-100.0MA	-20.00MA
324	10	-45.70MA	-100.0MA	-20.00MA
330	12	-45.30MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	1.000UA		20.00UA
350	3	7.700UA		20.00UA
354	5	0 A		20.00UA
358	9	-100.0NA		20.00UA
362	11	0 A		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	2.900UA		100.0UA
381	3	25.60UA		100.0UA
385	5	2.700UA		100.0UA
389	9	0 A		100.0UA
393	11	-100.0NA		100.0UA
397	13	0 A		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-240.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-230.0UA	-400.0UA	
425	9	-230.0UA	-400.0UA	
429	11	-240.0UA	-400.0UA	
433	13	-240.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.650MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	5.020MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 8

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-520.0MV	-1.500 V	-100.0MV
58	3	-530.0MV	-1.500 V	-100.0MV
58	5	-530.0MV	-1.500 V	-100.0MV
58	9	-530.0MV	-1.500 V	-100.0MV
58	11	-530.0MV	-1.500 V	-100.0MV
58	13	-530.0MV	-1.500 V	-100.0MV
58	14	-610.0MV	-1.500 V	-100.0MV
58	2	-680.0MV	-1.500 V	-100.0MV
58	4	-680.0MV	-1.500 V	-100.0MV
58	6	-680.0MV	-1.500 V	-100.0MV
58	8	-680.0MV	-1.500 V	-100.0MV
58	10	-680.0MV	-1.500 V	-100.0MV
58	12	-680.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.220 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-1.010 V	-1.500 V	
97	9	-930.0MV	-1.500 V	
103	11	-980.0MV	-1.500 V	
109	13	-1.080 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.850 V	2.500 V	
200	4	2.850 V	2.500 V	
206	6	2.850 V	2.500 V	
212	8	2.850 V	2.500 V	
218	10	2.850 V	2.500 V	
224	12	2.850 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	296.0MV		400.0MV
250	4	266.0MV		400.0MV
256	6	270.0MV		400.0MV
262	8	280.0MV		400.0MV
268	10	282.0MV		400.0MV
274	12	286.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.20MA	-100.0MA	-20.00MA
306	4	-48.40MA	-100.0MA	-20.00MA
312	6	-47.70MA	-100.0MA	-20.00MA
318	8	-46.50MA	-100.0MA	-20.00MA
324	10	-45.10MA	-100.0MA	-20.00MA
330	12	-45.20MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	1.000UA		20.00UA
350	3	8.700UA		20.00UA
354	5	200.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	3.000UA		100.0UA
381	3	29.50UA		100.0UA
385	5	1.700UA		100.0UA
389	9	0 A		100.0UA
393	11	0 A		100.0UA
397	13	300.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-230.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-230.0UA	-400.0UA	
425	9	-230.0UA	-400.0UA	
429	11	-230.0UA	-400.0UA	
433	13	-230.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.630MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.940MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```



STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 9

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-520.0MV	-1.500 V	-100.0MV
58	3	-530.0MV	-1.500 V	-100.0MV
58	5	-530.0MV	-1.500 V	-100.0MV
58	9	-530.0MV	-1.500 V	-100.0MV
58	11	-520.0MV	-1.500 V	-100.0MV
58	13	-530.0MV	-1.500 V	-100.0MV
58	14	-610.0MV	-1.500 V	-100.0MV
58	2	-680.0MV	-1.500 V	-100.0MV
58	4	-680.0MV	-1.500 V	-100.0MV
58	6	-680.0MV	-1.500 V	-100.0MV
58	8	-680.0MV	-1.500 V	-100.0MV
58	10	-680.0MV	-1.500 V	-100.0MV
58	12	-680.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.210 V	-1.500 V	
85	3	-960.0MV	-1.500 V	
91	5	-1.020 V	-1.500 V	
97	9	-930.0MV	-1.500 V	
103	11	-990.0MV	-1.500 V	
109	13	-1.090 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.850 V	2.500 V	
200	4	2.850 V	2.500 V	
206	6	2.850 V	2.500 V	
212	8	2.850 V	2.500 V	
218	10	2.840 V	2.500 V	
224	12	2.840 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	298.0MV		400.0MV
250	4	268.0MV		400.0MV
256	6	270.0MV		400.0MV
262	8	278.0MV		400.0MV
268	10	284.0MV		400.0MV
274	12	288.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.30MA	-100.0MA	-20.00MA
306	4	-48.40MA	-100.0MA	-20.00MA
312	6	-47.70MA	-100.0MA	-20.00MA
318	8	-47.00MA	-100.0MA	-20.00MA
324	10	-45.10MA	-100.0MA	-20.00MA
330	12	-45.40MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	500.0NA		20.00UA
350	3	2.000UA		20.00UA
354	5	300.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	1.500UA		100.0UA
381	3	7.600UA		100.0UA
385	5	1.500UA		100.0UA
389	9	100.0NA		100.0UA
393	11	0 A		100.0UA
397	13	3.700UA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-230.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-230.0UA	-400.0UA	
425	9	-230.0UA	-400.0UA	
429	11	-230.0UA	-400.0UA	
433	13	-240.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.620MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.970MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 10

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-530.0MV	-1.500 V	-100.0MV
58	3	-530.0MV	-1.500 V	-100.0MV
58	5	-530.0MV	-1.500 V	-100.0MV
58	9	-530.0MV	-1.500 V	-100.0MV
58	11	-530.0MV	-1.500 V	-100.0MV
58	13	-530.0MV	-1.500 V	-100.0MV
58	14	-620.0MV	-1.500 V	-100.0MV
58	2	-680.0MV	-1.500 V	-100.0MV
58	4	-680.0MV	-1.500 V	-100.0MV
58	6	-680.0MV	-1.500 V	-100.0MV
58	8	-690.0MV	-1.500 V	-100.0MV
58	10	-680.0MV	-1.500 V	-100.0MV
58	12	-680.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.230 V	-1.500 V	
85	3	-970.0MV	-1.500 V	
91	5	-1.030 V	-1.500 V	
97	9	-940.0MV	-1.500 V	
103	11	- 1 V	-1.500 V	
109	13	-1.100 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.840 V	2.500 V	
200	4	2.840 V	2.500 V	
206	6	2.840 V	2.500 V	
212	8	2.840 V	2.500 V	
218	10	2.840 V	2.500 V	
224	12	2.840 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	300.0MV		400.0MV
250	4	272.0MV		400.0MV
256	6	276.0MV		400.0MV
262	8	280.0MV		400.0MV
268	10	290.0MV		400.0MV
274	12	292.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.60MA	-100.0MA	-20.00MA
306	4	-48.40MA	-100.0MA	-20.00MA
312	6	-48.00MA	-100.0MA	-20.00MA
318	8	-47.30MA	-100.0MA	-20.00MA
324	10	-45.20MA	-100.0MA	-20.00MA
330	12	-45.60MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	700.0NA		20.00UA
350	3	500.0NA		20.00UA
354	5	700.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	300.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	3.000UA		100.0UA
381	3	2.300UA		100.0UA
385	5	2.500UA		100.0UA
389	9	100.0NA		100.0UA
393	11	100.0NA		100.0UA
397	13	3.000UA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-240.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-240.0UA	-400.0UA	
425	9	-240.0UA	-400.0UA	
429	11	-240.0UA	-400.0UA	
433	13	-240.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.650MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	5.050MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 11

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-530.0MV	-1.500 V	-100.0MV
58	3	-530.0MV	-1.500 V	-100.0MV
58	5	-530.0MV	-1.500 V	-100.0MV
58	9	-530.0MV	-1.500 V	-100.0MV
58	11	-530.0MV	-1.500 V	-100.0MV
58	13	-530.0MV	-1.500 V	-100.0MV
58	14	-610.0MV	-1.500 V	-100.0MV
58	2	-680.0MV	-1.500 V	-100.0MV
58	4	-680.0MV	-1.500 V	-100.0MV
58	6	-680.0MV	-1.500 V	-100.0MV
58	8	-680.0MV	-1.500 V	-100.0MV
58	10	-680.0MV	-1.500 V	-100.0MV
58	12	-680.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.220 V	-1.500 V	
85	3	-960.0MV	-1.500 V	
91	5	-1.020 V	-1.500 V	
97	9	-930.0MV	-1.500 V	
103	11	-980.0MV	-1.500 V	
109	13	-1.100 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.840 V	2.500 V	
200	4	2.840 V	2.500 V	
206	6	2.840 V	2.500 V	
212	8	2.840 V	2.500 V	
218	10	2.840 V	2.500 V	
224	12	2.840 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	296.0MV		400.0MV
250	4	268.0MV		400.0MV
256	6	270.0MV		400.0MV
262	8	306.0MV		400.0MV
268	10	280.0MV		400.0MV
274	12	290.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.50MA	-100.0MA	-20.00MA
306	4	-49.00MA	-100.0MA	-20.00MA
312	6	-48.20MA	-100.0MA	-20.00MA
318	8	-46.00MA	-100.0MA	-20.00MA
324	10	-45.90MA	-100.0MA	-20.00MA
330	12	-45.30MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	200.0NA		20.00UA
350	3	100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	400.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	1.200UA		100.0UA
381	3	1.400UA		100.0UA
385	5	0 A		100.0UA
389	9	200.0NA		100.0UA
393	11	0 A		100.0UA
397	13	2.800UA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-240.0UA	-400.0UA	
417	3	-240.0UA	-400.0UA	
421	5	-240.0UA	-400.0UA	
425	9	-240.0UA	-400.0UA	
429	11	-240.0UA	-400.0UA	
433	13	-240.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.670MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	5.130MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 12

DDS-101-14-A PN 54LS04 TEST SEQ12 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-520.0MV	-1.500 V	-100.0MV
58	3	-520.0MV	-1.500 V	-100.0MV
58	5	-520.0MV	-1.500 V	-100.0MV
58	9	-520.0MV	-1.500 V	-100.0MV
58	11	-520.0MV	-1.500 V	-100.0MV
58	13	-520.0MV	-1.500 V	-100.0MV
58	14	-600.0MV	-1.500 V	-100.0MV
58	2	-670.0MV	-1.500 V	-100.0MV
58	4	-670.0MV	-1.500 V	-100.0MV
58	6	-670.0MV	-1.500 V	-100.0MV
58	8	-670.0MV	-1.500 V	-100.0MV
58	10	-670.0MV	-1.500 V	-100.0MV
58	12	-670.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.220 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-1.020 V	-1.500 V	
97	9	-920.0MV	-1.500 V	
103	11	-980.0MV	-1.500 V	
109	13	-1.110 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.860 V	2.500 V	
200	4	2.860 V	2.500 V	
206	6	2.860 V	2.500 V	
212	8	2.860 V	2.500 V	
218	10	2.860 V	2.500 V	
224	12	2.860 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	294.0MV		400.0MV
250	4	266.0MV		400.0MV
256	6	270.0MV		400.0MV
262	8	274.0MV		400.0MV
268	10	280.0MV		400.0MV
274	12	288.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.10MA	-100.0MA	-20.00MA
306	4	-48.10MA	-100.0MA	-20.00MA
312	6	-47.50MA	-100.0MA	-20.00MA
318	8	-46.70MA	-100.0MA	-20.00MA
324	10	-44.80MA	-100.0MA	-20.00MA
330	12	-45.00MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	100.0NA		20.00UA
350	3	0 A		20.00UA
354	5	0 A		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	500.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	800.0NA		100.0UA
381	3	800.0NA		100.0UA
385	5	100.0NA		100.0UA
389	9	200.0NA		100.0UA
393	11	100.0NA		100.0UA
397	13	2.700UA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-230.0UA	-400.0UA	
417	3	-230.0UA	-400.0UA	
421	5	-230.0UA	-400.0UA	
425	9	-230.0UA	-400.0UA	
429	11	-230.0UA	-400.0UA	
433	13	-230.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.600MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.920MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```





# MIL-PRF-38534 CLASS K DATAPACK

---

Pre Burn-In Test Results at 25°C



STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 1

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-470.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-530.0MV	-1.500 V	-100.0MV
58	2	-600.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-600.0MV	-1.500 V	-100.0MV
58	8	-600.0MV	-1.500 V	-100.0MV
58	10	-600.0MV	-1.500 V	-100.0MV
58	12	-600.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.210 V	-1.500 V	
85	3	-940.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-960.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3 V	2.500 V	
200	4	3 V	2.500 V	
206	6	3 V	2.500 V	
212	8	3 V	2.500 V	
218	10	3 V	2.500 V	
224	12	3 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	288.0MV		400.0MV
250	4	254.0MV		400.0MV
256	6	256.0MV		400.0MV
262	8	276.0MV		400.0MV
268	10	268.0MV		400.0MV
274	12	286.0MV		400.0MV

-----

FUNCTIONAL TEST  
VCC= 5.500  
VIH= 2 VIL= 700.0E-03

-----  
IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-41.80MA	-100.0MA	-20.00MA
306	4	-45.70MA	-100.0MA	-20.00MA
312	6	-45.30MA	-100.0MA	-20.00MA
318	8	-42.20MA	-100.0MA	-20.00MA
324	10	-43.10MA	-100.0MA	-20.00MA
330	12	-43.20MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

IIIL TEST -400UA MAXVIN=0.4V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.420MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.490MA		6.600MA

EIR 1.....10 FCT DCT  
0000000000 PASS PASS EOT

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 2

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.120 V	-1.500 V	
85	3	-940.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-970.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	286.0MV		400.0MV
250	4	256.0MV		400.0MV
256	6	256.0MV		400.0MV
262	8	316.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	282.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.00MA	-100.0MA	-20.00MA
306	4	-45.70MA	-100.0MA	-20.00MA
312	6	-45.40MA	-100.0MA	-20.00MA
318	8	-41.20MA	-100.0MA	-20.00MA
324	10	-43.40MA	-100.0MA	-20.00MA
330	12	-43.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	0 A		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.430MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.470MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 3

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.120 V	-1.500 V	
85	3	-940.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-970.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	284.0MV		400.0MV
250	4	252.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	320.0MV		400.0MV
268	10	270.0MV		400.0MV
274	12	276.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.30MA	-100.0MA	-20.00MA
306	4	-46.10MA	-100.0MA	-20.00MA
312	6	-45.80MA	-100.0MA	-20.00MA
318	8	-42.50MA	-100.0MA	-20.00MA
324	10	-43.60MA	-100.0MA	-20.00MA
330	12	-43.60MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.450MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.540MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 4

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.130 V	-1.500 V	
85	3	-940.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-970.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	284.0MV		400.0MV
250	4	254.0MV		400.0MV
256	6	252.0MV		400.0MV
262	8	294.0MV		400.0MV
268	10	270.0MV		400.0MV
274	12	274.0MV		400.0MV



```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.60MA	-100.0MA	-20.00MA
306	4	-46.30MA	-100.0MA	-20.00MA
312	6	-45.80MA	-100.0MA	-20.00MA
318	8	-42.30MA	-100.0MA	-20.00MA
324	10	-43.70MA	-100.0MA	-20.00MA
330	12	-43.90MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.460MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.570MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 5

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.130 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-970.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	284.0MV		400.0MV
250	4	256.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	268.0MV		400.0MV
268	10	270.0MV		400.0MV
274	12	276.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.50MA	-100.0MA	-20.00MA
306	4	-46.00MA	-100.0MA	-20.00MA
312	6	-45.60MA	-100.0MA	-20.00MA
318	8	-44.10MA	-100.0MA	-20.00MA
324	10	-43.30MA	-100.0MA	-20.00MA
330	12	-43.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	0 A		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.440MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.520MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 6

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-490.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-490.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.140 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-970.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.980 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	282.0MV		400.0MV
250	4	256.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	266.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	276.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.50MA	-100.0MA	-20.00MA
306	4	-45.80MA	-100.0MA	-20.00MA
312	6	-45.50MA	-100.0MA	-20.00MA
318	8	-44.10MA	-100.0MA	-20.00MA
324	10	-43.00MA	-100.0MA	-20.00MA
330	12	-43.40MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	0 A		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.410MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.440MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 7

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.160 V	-1.500 V	
85	3	-940.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-970.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	3 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	278.0MV		400.0MV
250	4	252.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	272.0MV		400.0MV
268	10	270.0MV		400.0MV
274	12	274.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-43.00MA	-100.0MA	-20.00MA
306	4	-46.00MA	-100.0MA	-20.00MA
312	6	-45.60MA	-100.0MA	-20.00MA
318	8	-43.50MA	-100.0MA	-20.00MA
324	10	-43.40MA	-100.0MA	-20.00MA
330	12	-43.60MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	0 A		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.420MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.470MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 8

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-490.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.160 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-980.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	280.0MV		400.0MV
250	4	256.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	272.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	290.0MV		400.0MV



```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.90MA	-100.0MA	-20.00MA
306	4	-45.80MA	-100.0MA	-20.00MA
312	6	-45.50MA	-100.0MA	-20.00MA
318	8	-43.60MA	-100.0MA	-20.00MA
324	10	-43.10MA	-100.0MA	-20.00MA
330	12	-43.40MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.410MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.440MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 9

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-660.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.180 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-940.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-980.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	3 V	2.500 V	
206	6	3 V	2.500 V	
212	8	3 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	278.0MV		400.0MV
250	4	254.0MV		400.0MV
256	6	256.0MV		400.0MV
262	8	280.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	296.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.60MA	-100.0MA	-20.00MA
306	4	-45.50MA	-100.0MA	-20.00MA
312	6	-45.20MA	-100.0MA	-20.00MA
318	8	-43.10MA	-100.0MA	-20.00MA
324	10	-43.10MA	-100.0MA	-20.00MA
330	12	-43.20MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	0 A		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.410MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.420MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 10

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-600.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.190 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-990.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	3 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	278.0MV		400.0MV
250	4	252.0MV		400.0MV
256	6	256.0MV		400.0MV
262	8	348.0MV		400.0MV
268	10	270.0MV		400.0MV
274	12	294.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-43.00MA	-100.0MA	-20.00MA
306	4	-45.60MA	-100.0MA	-20.00MA
312	6	-45.60MA	-100.0MA	-20.00MA
318	8	-40.20MA	-100.0MA	-20.00MA
324	10	-42.80MA	-100.0MA	-20.00MA
330	12	-43.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.430MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.500MA		6.600MA

```

EIR 1.....10      FCT   DCT
    0000000000    PASS  PASS  EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 11

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-600.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-720.0MV	-1.500 V	-100.0MV
58	10	-600.0MV	-1.500 V	-100.0MV
58	12	-600.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.200 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-940.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-990.0MV	-1.500 V	
109	13	-920.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3 V	2.500 V	
200	4	3 V	2.500 V	
206	6	3 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	3 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	280.0MV		400.0MV
250	4	254.0MV		400.0MV
256	6	252.0MV		400.0MV
262	8	356.0MV		400.0MV
268	10	268.0MV		400.0MV
274	12	296.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.70MA	-100.0MA	-20.00MA
306	4	-46.10MA	-100.0MA	-20.00MA
312	6	-45.60MA	-100.0MA	-20.00MA
318	8	-41.60MA	-100.0MA	-20.00MA
324	10	-43.40MA	-100.0MA	-20.00MA
330	12	-43.40MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.440MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.540MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 12

DDS-101-14-A PN 54LS04 TEST SEQ12 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-600.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-600.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.240 V	-1.500 V	
85	3	-950.0MV	-1.500 V	
91	5	-940.0MV	-1.500 V	
97	9	-890.0MV	-1.500 V	
103	11	-1.010 V	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	3 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	3 V	2.500 V	
218	10	3 V	2.500 V	
224	12	3 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	282.0MV		400.0MV
250	4	256.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	278.0MV		400.0MV
268	10	270.0MV		400.0MV
274	12	300.0MV		400.0MV



```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.60MA	-100.0MA	-20.00MA
306	4	-45.40MA	-100.0MA	-20.00MA
312	6	-45.10MA	-100.0MA	-20.00MA
318	8	-42.80MA	-100.0MA	-20.00MA
324	10	-42.90MA	-100.0MA	-20.00MA
330	12	-43.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.400MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.390MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```



# MIL-PRF-38534 CLASS K DATAPACK

---

Pre Burn-In Test Results at +125°C



STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 1  
DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-430.0MV	-1.500 V	-100.0MV
58	3	-430.0MV	-1.500 V	-100.0MV
58	5	-430.0MV	-1.500 V	-100.0MV
58	9	-420.0MV	-1.500 V	-100.0MV
58	11	-430.0MV	-1.500 V	-100.0MV
58	13	-420.0MV	-1.500 V	-100.0MV
58	14	-450.0MV	-1.500 V	-100.0MV
58	2	-520.0MV	-1.500 V	-100.0MV
58	4	-520.0MV	-1.500 V	-100.0MV
58	6	-520.0MV	-1.500 V	-100.0MV
58	8	-520.0MV	-1.500 V	-100.0MV
58	10	-520.0MV	-1.500 V	-100.0MV
58	12	-520.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.320 V	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-930.0MV	-1.500 V	
97	9	-840.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-1.030 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.120 V	2.500 V	
200	4	3.130 V	2.500 V	
206	6	3.130 V	2.500 V	
212	8	3.120 V	2.500 V	
218	10	3.100 V	2.500 V	
224	12	3.130 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	276.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	244.0MV		400.0MV
262	8	256.0MV		400.0MV
268	10	256.0MV		400.0MV
274	12	266.0MV		400.0MV

-----

FUNCTIONAL TEST  
VCC= 5.500  
VIH= 2 VIL= 700.0E-03

-----  
IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-39.40MA	-100.0MA	-20.00MA
306	4	-42.50MA	-100.0MA	-20.00MA
312	6	-41.80MA	-100.0MA	-20.00MA
318	8	-40.40MA	-100.0MA	-20.00MA
324	10	-39.50MA	-100.0MA	-20.00MA
330	12	-39.80MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	0 A		100.0UA
385	5	0 A		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

IIIL TEST -400UA MAXVIN=0.4V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-180.0UA	-400.0UA	
417	3	-170.0UA	-400.0UA	
421	5	-170.0UA	-400.0UA	
425	9	-170.0UA	-400.0UA	
429	11	-180.0UA	-400.0UA	
433	13	-180.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.220MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.910MA		6.600MA

EIR 1.....10 FCT DCT  
0000000000 PASS PASS EOT

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 2

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-420.0MV	-1.500 V	-100.0MV
58	3	-420.0MV	-1.500 V	-100.0MV
58	5	-420.0MV	-1.500 V	-100.0MV
58	9	-420.0MV	-1.500 V	-100.0MV
58	11	-420.0MV	-1.500 V	-100.0MV
58	13	-420.0MV	-1.500 V	-100.0MV
58	14	-440.0MV	-1.500 V	-100.0MV
58	2	-520.0MV	-1.500 V	-100.0MV
58	4	-510.0MV	-1.500 V	-100.0MV
58	6	-510.0MV	-1.500 V	-100.0MV
58	8	-520.0MV	-1.500 V	-100.0MV
58	10	-510.0MV	-1.500 V	-100.0MV
58	12	-510.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.300 V	-1.500 V	
85	3	-1.010 V	-1.500 V	
91	5	-1.090 V	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-1.020 V	-1.500 V	
109	13	-1.280 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.120 V	2.500 V	
200	4	3.130 V	2.500 V	
206	6	3.130 V	2.500 V	
212	8	3.130 V	2.500 V	
218	10	3.100 V	2.500 V	
224	12	3.130 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	310.0MV		400.0MV
250	4	268.0MV		400.0MV
256	6	268.0MV		400.0MV
262	8	282.0MV		400.0MV
268	10	284.0MV		400.0MV
274	12	288.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-39.10MA	-100.0MA	-20.00MA
306	4	-42.20MA	-100.0MA	-20.00MA
312	6	-41.60MA	-100.0MA	-20.00MA
318	8	-40.70MA	-100.0MA	-20.00MA
324	10	-39.20MA	-100.0MA	-20.00MA
330	12	-39.80MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	0 A		20.00UA
362	11	-100.0NA		20.00UA
366	13	0 A		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-180.0UA	-400.0UA	
417	3	-180.0UA	-400.0UA	
421	5	-170.0UA	-400.0UA	
425	9	-170.0UA	-400.0UA	
429	11	-180.0UA	-400.0UA	
433	13	-180.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.210MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.860MA		6.600MA

```

EIR 1.....10      FCT   DCT
    0000000000    PASS  PASS  EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 3

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-440.0MV	-1.500 V	-100.0MV
58	3	-440.0MV	-1.500 V	-100.0MV
58	5	-440.0MV	-1.500 V	-100.0MV
58	9	-440.0MV	-1.500 V	-100.0MV
58	11	-440.0MV	-1.500 V	-100.0MV
58	13	-440.0MV	-1.500 V	-100.0MV
58	14	-470.0MV	-1.500 V	-100.0MV
58	2	-540.0MV	-1.500 V	-100.0MV
58	4	-540.0MV	-1.500 V	-100.0MV
58	6	-540.0MV	-1.500 V	-100.0MV
58	8	-540.0MV	-1.500 V	-100.0MV
58	10	-540.0MV	-1.500 V	-100.0MV
58	12	-540.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.200 V	-1.500 V	
85	3	-940.0MV	-1.500 V	
91	5	-1.010 V	-1.500 V	
97	9	-900.0MV	-1.500 V	
103	11	-950.0MV	-1.500 V	
109	13	-960.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.110 V	2.500 V	
200	4	3.110 V	2.500 V	
206	6	3.110 V	2.500 V	
212	8	3.110 V	2.500 V	
218	10	3.100 V	2.500 V	
224	12	3.120 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	296.0MV		400.0MV
250	4	258.0MV		400.0MV
256	6	258.0MV		400.0MV
262	8	266.0MV		400.0MV
268	10	270.0MV		400.0MV
274	12	280.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-39.60MA	-100.0MA	-20.00MA
306	4	-43.40MA	-100.0MA	-20.00MA
312	6	-42.70MA	-100.0MA	-20.00MA
318	8	-42.10MA	-100.0MA	-20.00MA
324	10	-39.90MA	-100.0MA	-20.00MA
330	12	-40.40MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	0 A		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	0 A		100.0UA
381	3	-100.0NA		100.0UA
385	5	0 A		100.0UA
389	9	0 A		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-180.0UA	-400.0UA	
417	3	-180.0UA	-400.0UA	
421	5	-180.0UA	-400.0UA	
425	9	-180.0UA	-400.0UA	
429	11	-180.0UA	-400.0UA	
433	13	-180.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.260MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.030MA		6.600MA

```

EIR 1.....10      FCT   DCT
    0000000000    PASS  PASS  EOT

```



STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 4

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-410.0MV	-1.500 V	-100.0MV
58	3	-410.0MV	-1.500 V	-100.0MV
58	5	-410.0MV	-1.500 V	-100.0MV
58	9	-410.0MV	-1.500 V	-100.0MV
58	11	-410.0MV	-1.500 V	-100.0MV
58	13	-410.0MV	-1.500 V	-100.0MV
58	14	-430.0MV	-1.500 V	-100.0MV
58	2	-510.0MV	-1.500 V	-100.0MV
58	4	-510.0MV	-1.500 V	-100.0MV
58	6	-510.0MV	-1.500 V	-100.0MV
58	8	-510.0MV	-1.500 V	-100.0MV
58	10	-510.0MV	-1.500 V	-100.0MV
58	12	-510.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.200 V	-1.500 V	
85	3	-930.0MV	-1.500 V	
91	5	- 1 V	-1.500 V	
97	9	-900.0MV	-1.500 V	
103	11	-950.0MV	-1.500 V	
109	13	-960.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.130 V	2.500 V	
200	4	3.120 V	2.500 V	
206	6	3.130 V	2.500 V	
212	8	3.130 V	2.500 V	
218	10	3.100 V	2.500 V	
224	12	3.130 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	298.0MV		400.0MV
250	4	272.0MV		400.0MV
256	6	272.0MV		400.0MV
262	8	276.0MV		400.0MV
268	10	322.0MV		400.0MV
274	12	294.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-39.90MA	-100.0MA	-20.00MA
306	4	-42.70MA	-100.0MA	-20.00MA
312	6	-42.00MA	-100.0MA	-20.00MA
318	8	-41.50MA	-100.0MA	-20.00MA
324	10	-40.50MA	-100.0MA	-20.00MA
330	12	-40.00MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	0 A		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	0 A		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-180.0UA	-400.0UA	
417	3	-180.0UA	-400.0UA	
421	5	-180.0UA	-400.0UA	
425	9	-180.0UA	-400.0UA	
429	11	-180.0UA	-400.0UA	
433	13	-180.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.240MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.960MA		6.600MA

```

EIR 1.....10      FCT   DCT
    0000000000    PASS  PASS  EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 5

DDS-101-14-A PN 54LS04 TEST SEQ2 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-390.0MV	-1.500 V	-100.0MV
58	3	-390.0MV	-1.500 V	-100.0MV
58	5	-390.0MV	-1.500 V	-100.0MV
58	9	-390.0MV	-1.500 V	-100.0MV
58	11	-390.0MV	-1.500 V	-100.0MV
58	13	-390.0MV	-1.500 V	-100.0MV
58	14	-400.0MV	-1.500 V	-100.0MV
58	2	-480.0MV	-1.500 V	-100.0MV
58	4	-480.0MV	-1.500 V	-100.0MV
58	6	-480.0MV	-1.500 V	-100.0MV
58	8	-480.0MV	-1.500 V	-100.0MV
58	10	-480.0MV	-1.500 V	-100.0MV
58	12	-480.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.180 V	-1.500 V	
85	3	-890.0MV	-1.500 V	
91	5	-960.0MV	-1.500 V	
97	9	-860.0MV	-1.500 V	
103	11	-920.0MV	-1.500 V	
109	13	-930.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.100 V	2.500 V	
200	4	3.090 V	2.500 V	
206	6	3.110 V	2.500 V	
212	8	3.100 V	2.500 V	
218	10	3.050 V	2.500 V	
224	12	3.110 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	326.0MV		400.0MV
250	4	260.0MV		400.0MV
256	6	262.0MV		400.0MV
262	8	264.0MV		400.0MV
268	10	290.0MV		400.0MV
274	12	280.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-39.00MA	-100.0MA	-20.00MA
306	4	-41.90MA	-100.0MA	-20.00MA
312	6	-41.30MA	-100.0MA	-20.00MA
318	8	-40.80MA	-100.0MA	-20.00MA
324	10	-38.60MA	-100.0MA	-20.00MA
330	12	-39.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	0 A		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	0 A		100.0UA
381	3	0 A		100.0UA
385	5	0 A		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-170.0UA	-400.0UA	
417	3	-170.0UA	-400.0UA	
421	5	-170.0UA	-400.0UA	
425	9	-170.0UA	-400.0UA	
429	11	-170.0UA	-400.0UA	
433	13	-170.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.200MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.830MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 6

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-450.0MV	-1.500 V	-100.0MV
58	3	-450.0MV	-1.500 V	-100.0MV
58	5	-450.0MV	-1.500 V	-100.0MV
58	9	-450.0MV	-1.500 V	-100.0MV
58	11	-450.0MV	-1.500 V	-100.0MV
58	13	-460.0MV	-1.500 V	-100.0MV
58	14	-490.0MV	-1.500 V	-100.0MV
58	2	-570.0MV	-1.500 V	-100.0MV
58	4	-570.0MV	-1.500 V	-100.0MV
58	6	-570.0MV	-1.500 V	-100.0MV
58	8	-580.0MV	-1.500 V	-100.0MV
58	10	-560.0MV	-1.500 V	-100.0MV
58	12	-570.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.420 V	-1.500 V	
85	3	-1.120 V	-1.500 V	
91	5	-1.290 V	-1.500 V	
97	9	-1.040 V	-1.500 V	
103	11	-1.120 V	-1.500 V	
109	13	-1.110 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.090 V	2.500 V	
200	4	3.090 V	2.500 V	
206	6	3.090 V	2.500 V	
212	8	3.080 V	2.500 V	
218	10	3.090 V	2.500 V	
224	12	3.090 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	286.0MV		400.0MV
250	4	258.0MV		400.0MV
256	6	260.0MV		400.0MV
262	8	346.0MV		400.0MV
268	10	282.0MV		400.0MV
274	12	276.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-41.00MA	-100.0MA	-20.00MA
306	4	-44.00MA	-100.0MA	-20.00MA
312	6	-43.50MA	-100.0MA	-20.00MA
318	8	-40.40MA	-100.0MA	-20.00MA
324	10	-40.20MA	-100.0MA	-20.00MA
330	12	-41.40MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-190.0UA	-400.0UA	
417	3	-190.0UA	-400.0UA	
421	5	-190.0UA	-400.0UA	
425	9	-190.0UA	-400.0UA	
429	11	-190.0UA	-400.0UA	
433	13	-190.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.290MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.090MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 7

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-440.0MV	-1.500 V	-100.0MV
58	3	-430.0MV	-1.500 V	-100.0MV
58	5	-430.0MV	-1.500 V	-100.0MV
58	9	-430.0MV	-1.500 V	-100.0MV
58	11	-430.0MV	-1.500 V	-100.0MV
58	13	-430.0MV	-1.500 V	-100.0MV
58	14	-460.0MV	-1.500 V	-100.0MV
58	2	-530.0MV	-1.500 V	-100.0MV
58	4	-530.0MV	-1.500 V	-100.0MV
58	6	-530.0MV	-1.500 V	-100.0MV
58	8	-540.0MV	-1.500 V	-100.0MV
58	10	-530.0MV	-1.500 V	-100.0MV
58	12	-530.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.400 V	-1.500 V	
85	3	-1.090 V	-1.500 V	
91	5	-1.150 V	-1.500 V	
97	9	-1.060 V	-1.500 V	
103	11	-1.130 V	-1.500 V	
109	13	-1.130 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.120 V	2.500 V	
200	4	3.130 V	2.500 V	
206	6	3.130 V	2.500 V	
212	8	3.130 V	2.500 V	
218	10	3.110 V	2.500 V	
224	12	3.130 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	346.0MV		400.0MV
250	4	320.0MV		400.0MV
256	6	320.0MV		400.0MV
262	8	346.0MV		400.0MV
268	10	354.0MV		400.0MV
274	12	338.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC=      5.500
VIH=      2      VIL=      700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-40.20MA	-100.0MA	-20.00MA
306	4	-42.90MA	-100.0MA	-20.00MA
312	6	-42.40MA	-100.0MA	-20.00MA
318	8	-40.30MA	-100.0MA	-20.00MA
324	10	-41.60MA	-100.0MA	-20.00MA
330	12	-40.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-180.0UA	-400.0UA	
417	3	-180.0UA	-400.0UA	
421	5	-180.0UA	-400.0UA	
425	9	-180.0UA	-400.0UA	
429	11	-180.0UA	-400.0UA	
433	13	-180.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.220MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.900MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```



STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 8

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-450.0MV	-1.500 V	-100.0MV
58	3	-450.0MV	-1.500 V	-100.0MV
58	5	-450.0MV	-1.500 V	-100.0MV
58	9	-450.0MV	-1.500 V	-100.0MV
58	11	-450.0MV	-1.500 V	-100.0MV
58	13	-450.0MV	-1.500 V	-100.0MV
58	14	-480.0MV	-1.500 V	-100.0MV
58	2	-550.0MV	-1.500 V	-100.0MV
58	4	-550.0MV	-1.500 V	-100.0MV
58	6	-550.0MV	-1.500 V	-100.0MV
58	8	-550.0MV	-1.500 V	-100.0MV
58	10	-550.0MV	-1.500 V	-100.0MV
58	12	-550.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.370 V	-1.500 V	
85	3	-990.0MV	-1.500 V	
91	5	-1.050 V	-1.500 V	
97	9	-960.0MV	-1.500 V	
103	11	-1.030 V	-1.500 V	
109	13	-1.090 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.100 V	2.500 V	
200	4	3.110 V	2.500 V	
206	6	3.110 V	2.500 V	
212	8	3.110 V	2.500 V	
218	10	3.100 V	2.500 V	
224	12	3.110 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	320.0MV		400.0MV
250	4	292.0MV		400.0MV
256	6	294.0MV		400.0MV
262	8	300.0MV		400.0MV
268	10	306.0MV		400.0MV
274	12	312.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-40.50MA	-100.0MA	-20.00MA
306	4	-43.30MA	-100.0MA	-20.00MA
312	6	-42.80MA	-100.0MA	-20.00MA
318	8	-42.00MA	-100.0MA	-20.00MA
324	10	-41.90MA	-100.0MA	-20.00MA
330	12	-40.80MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-180.0UA	-400.0UA	
417	3	-180.0UA	-400.0UA	
421	5	-180.0UA	-400.0UA	
425	9	-180.0UA	-400.0UA	
429	11	-180.0UA	-400.0UA	
433	13	-180.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.240MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.930MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 9

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-430.0MV	-1.500 V	-100.0MV
58	3	-430.0MV	-1.500 V	-100.0MV
58	5	-430.0MV	-1.500 V	-100.0MV
58	9	-430.0MV	-1.500 V	-100.0MV
58	11	-430.0MV	-1.500 V	-100.0MV
58	13	-430.0MV	-1.500 V	-100.0MV
58	14	-450.0MV	-1.500 V	-100.0MV
58	2	-530.0MV	-1.500 V	-100.0MV
58	4	-520.0MV	-1.500 V	-100.0MV
58	6	-530.0MV	-1.500 V	-100.0MV
58	8	-530.0MV	-1.500 V	-100.0MV
58	10	-520.0MV	-1.500 V	-100.0MV
58	12	-520.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.250 V	-1.500 V	
85	3	-970.0MV	-1.500 V	
91	5	-1.040 V	-1.500 V	
97	9	-950.0MV	-1.500 V	
103	11	-1.010 V	-1.500 V	
109	13	-1.090 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.130 V	2.500 V	
200	4	3.130 V	2.500 V	
206	6	3.130 V	2.500 V	
212	8	3.120 V	2.500 V	
218	10	3.110 V	2.500 V	
224	12	3.130 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	320.0MV		400.0MV
250	4	290.0MV		400.0MV
256	6	292.0MV		400.0MV
262	8	332.0MV		400.0MV
268	10	302.0MV		400.0MV
274	12	310.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-39.80MA	-100.0MA	-20.00MA
306	4	-42.40MA	-100.0MA	-20.00MA
312	6	-41.90MA	-100.0MA	-20.00MA
318	8	-39.00MA	-100.0MA	-20.00MA
324	10	-41.20MA	-100.0MA	-20.00MA
330	12	-40.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	0 A		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-170.0UA	-400.0UA	
417	3	-180.0UA	-400.0UA	
421	5	-170.0UA	-400.0UA	
425	9	-170.0UA	-400.0UA	
429	11	-170.0UA	-400.0UA	
433	13	-170.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.200MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.830MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 10

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-430.0MV	-1.500 V	-100.0MV
58	3	-430.0MV	-1.500 V	-100.0MV
58	5	-430.0MV	-1.500 V	-100.0MV
58	9	-430.0MV	-1.500 V	-100.0MV
58	11	-430.0MV	-1.500 V	-100.0MV
58	13	-430.0MV	-1.500 V	-100.0MV
58	14	-450.0MV	-1.500 V	-100.0MV
58	2	-530.0MV	-1.500 V	-100.0MV
58	4	-530.0MV	-1.500 V	-100.0MV
58	6	-530.0MV	-1.500 V	-100.0MV
58	8	-530.0MV	-1.500 V	-100.0MV
58	10	-530.0MV	-1.500 V	-100.0MV
58	12	-520.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.250 V	-1.500 V	
85	3	-980.0MV	-1.500 V	
91	5	-1.030 V	-1.500 V	
97	9	-950.0MV	-1.500 V	
103	11	-1.010 V	-1.500 V	
109	13	-1.100 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.120 V	2.500 V	
200	4	3.130 V	2.500 V	
206	6	3.130 V	2.500 V	
212	8	3.130 V	2.500 V	
218	10	3.110 V	2.500 V	
224	12	3.130 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	318.0MV		400.0MV
250	4	290.0MV		400.0MV
256	6	292.0MV		400.0MV
262	8	298.0MV		400.0MV
268	10	300.0MV		400.0MV
274	12	310.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-40.10MA	-100.0MA	-20.00MA
306	4	-42.60MA	-100.0MA	-20.00MA
312	6	-42.40MA	-100.0MA	-20.00MA
318	8	-41.80MA	-100.0MA	-20.00MA
324	10	-41.30MA	-100.0MA	-20.00MA
330	12	-40.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	0 A		100.0UA
397	13	0 A		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-180.0UA	-400.0UA	
417	3	-180.0UA	-400.0UA	
421	5	-180.0UA	-400.0UA	
425	9	-180.0UA	-400.0UA	
429	11	-180.0UA	-400.0UA	
433	13	-180.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.240MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.930MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 11

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-390.0MV	-1.500 V	-100.0MV
58	3	-390.0MV	-1.500 V	-100.0MV
58	5	-390.0MV	-1.500 V	-100.0MV
58	9	-390.0MV	-1.500 V	-100.0MV
58	11	-390.0MV	-1.500 V	-100.0MV
58	13	-390.0MV	-1.500 V	-100.0MV
58	14	-400.0MV	-1.500 V	-100.0MV
58	2	-480.0MV	-1.500 V	-100.0MV
58	4	-480.0MV	-1.500 V	-100.0MV
58	6	-480.0MV	-1.500 V	-100.0MV
58	8	-480.0MV	-1.500 V	-100.0MV
58	10	-480.0MV	-1.500 V	-100.0MV
58	12	-480.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.330 V	-1.500 V	
85	3	-960.0MV	-1.500 V	
91	5	-1.030 V	-1.500 V	
97	9	-930.0MV	-1.500 V	
103	11	-990.0MV	-1.500 V	
109	13	-1.040 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.110 V	2.500 V	
200	4	3.110 V	2.500 V	
206	6	3.120 V	2.500 V	
212	8	3.110 V	2.500 V	
218	10	3.070 V	2.500 V	
224	12	3.110 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	318.0MV		400.0MV
250	4	290.0MV		400.0MV
256	6	292.0MV		400.0MV
262	8	296.0MV		400.0MV
268	10	300.0MV		400.0MV
274	12	312.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-39.10MA	-100.0MA	-20.00MA
306	4	-42.00MA	-100.0MA	-20.00MA
312	6	-41.40MA	-100.0MA	-20.00MA
318	8	-40.80MA	-100.0MA	-20.00MA
324	10	-40.70MA	-100.0MA	-20.00MA
330	12	-39.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	0 A		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-170.0UA	-400.0UA	
417	3	-170.0UA	-400.0UA	
421	5	-170.0UA	-400.0UA	
425	9	-170.0UA	-400.0UA	
429	11	-170.0UA	-400.0UA	
433	13	-170.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.200MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.840MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```



STAT1 08/01/11 08:19  
TEST PROGRAM 4LS04 S/N 12

DDS-101-14-A PN 54LS04 TEST SEQ12 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-440.0MV	-1.500 V	-100.0MV
58	3	-440.0MV	-1.500 V	-100.0MV
58	5	-440.0MV	-1.500 V	-100.0MV
58	9	-440.0MV	-1.500 V	-100.0MV
58	11	-440.0MV	-1.500 V	-100.0MV
58	13	-440.0MV	-1.500 V	-100.0MV
58	14	-470.0MV	-1.500 V	-100.0MV
58	2	-540.0MV	-1.500 V	-100.0MV
58	4	-540.0MV	-1.500 V	-100.0MV
58	6	-540.0MV	-1.500 V	-100.0MV
58	8	-540.0MV	-1.500 V	-100.0MV
58	10	-540.0MV	-1.500 V	-100.0MV
58	12	-540.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.290 V	-1.500 V	
85	3	-990.0MV	-1.500 V	
91	5	-1.050 V	-1.500 V	
97	9	-960.0MV	-1.500 V	
103	11	-1.020 V	-1.500 V	
109	13	-1.070 V	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.110 V	2.500 V	
200	4	3.110 V	2.500 V	
206	6	3.110 V	2.500 V	
212	8	3.110 V	2.500 V	
218	10	3.100 V	2.500 V	
224	12	3.110 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	322.0MV		400.0MV
250	4	294.0MV		400.0MV
256	6	296.0MV		400.0MV
262	8	338.0MV		400.0MV
268	10	306.0MV		400.0MV
274	12	314.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-40.70MA	-100.0MA	-20.00MA
306	4	-43.20MA	-100.0MA	-20.00MA
312	6	-42.70MA	-100.0MA	-20.00MA
318	8	-40.30MA	-100.0MA	-20.00MA
324	10	-42.00MA	-100.0MA	-20.00MA
330	12	-41.00MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	0 A		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	0 A		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-180.0UA	-400.0UA	
417	3	-180.0UA	-400.0UA	
421	5	-180.0UA	-400.0UA	
425	9	-180.0UA	-400.0UA	
429	11	-180.0UA	-400.0UA	
433	13	-180.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.260MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	3.990MA		6.600MA

```

EIR 1.....10 FCT DCT
0000000000 PASS PASS EOT

```



# MIL-PRF-38534 CLASS K DATAPACK

---

Post Burn-In Test Results at -55°C



STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 1  
DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-500.0MV	-1.500 V	-100.0MV
58	3	-500.0MV	-1.500 V	-100.0MV
58	5	-700.0MV	-1.500 V	-100.0MV
58	9	-500.0MV	-1.500 V	-100.0MV
58	11	-500.0MV	-1.500 V	-100.0MV
58	13	-500.0MV	-1.500 V	-100.0MV
58	14	-570.0MV	-1.500 V	-100.0MV
58	2	-640.0MV	-1.500 V	-100.0MV
58	4	-630.0MV	-1.500 V	-100.0MV
58	6	-640.0MV	-1.500 V	-100.0MV
58	8	-640.0MV	-1.500 V	-100.0MV
58	10	-630.0MV	-1.500 V	-100.0MV
58	12	-640.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-950.0MV	-1.500 V	
85	3	-890.0MV	-1.500 V	
91	5	- 1 V	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-910.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.940 V	2.500 V	
200	4	2.940 V	2.500 V	
206	6	2.940 V	2.500 V	
212	8	2.940 V	2.500 V	
218	10	2.940 V	2.500 V	
224	12	2.930 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	272.0MV		400.0MV
250	4	250.0MV		400.0MV
256	6	266.0MV		400.0MV
262	8	262.0MV		400.0MV
268	10	276.0MV		400.0MV
274	12	256.0MV		400.0MV

-----

FUNCTIONAL TEST  
VCC= 5.500  
VIH= 2 VIL= 700.0E-03

---

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-45.30MA	-100.0MA	-20.00MA
306	4	-47.90MA	-100.0MA	-20.00MA
312	6	-45.80MA	-100.0MA	-20.00MA
318	8	-45.60MA	-100.0MA	-20.00MA
324	10	-44.40MA	-100.0MA	-20.00MA
330	12	-47.20MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4V VCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-220.0UA	-400.0UA	
425	9	-220.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.520MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.760MA		6.600MA

EIR 1.....10 FCT DCT  
0000000000 PASS PASS EOT

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 2

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-490.0MV	-1.500 V	-100.0MV
58	3	-490.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-490.0MV	-1.500 V	-100.0MV
58	11	-490.0MV	-1.500 V	-100.0MV
58	13	-490.0MV	-1.500 V	-100.0MV
58	14	-560.0MV	-1.500 V	-100.0MV
58	2	-630.0MV	-1.500 V	-100.0MV
58	4	-630.0MV	-1.500 V	-100.0MV
58	6	-630.0MV	-1.500 V	-100.0MV
58	8	-630.0MV	-1.500 V	-100.0MV
58	10	-630.0MV	-1.500 V	-100.0MV
58	12	-630.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-940.0MV	-1.500 V	
85	3	-890.0MV	-1.500 V	
91	5	-1.060 V	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.930 V	2.500 V	
200	4	2.930 V	2.500 V	
206	6	2.930 V	2.500 V	
212	8	2.930 V	2.500 V	
218	10	2.930 V	2.500 V	
224	12	2.930 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	274.0MV		400.0MV
250	4	250.0MV		400.0MV
256	6	262.0MV		400.0MV
262	8	264.0MV		400.0MV
268	10	278.0MV		400.0MV
274	12	258.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-45.20MA	-100.0MA	-20.00MA
306	4	-47.90MA	-100.0MA	-20.00MA
312	6	-46.10MA	-100.0MA	-20.00MA
318	8	-46.20MA	-100.0MA	-20.00MA
324	10	-44.60MA	-100.0MA	-20.00MA
330	12	-47.60MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-220.0UA	-400.0UA	
425	9	-220.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.540MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.780MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 3

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-490.0MV	-1.500 V	-100.0MV
58	3	-490.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-490.0MV	-1.500 V	-100.0MV
58	11	-490.0MV	-1.500 V	-100.0MV
58	13	-490.0MV	-1.500 V	-100.0MV
58	14	-550.0MV	-1.500 V	-100.0MV
58	2	-620.0MV	-1.500 V	-100.0MV
58	4	-620.0MV	-1.500 V	-100.0MV
58	6	-620.0MV	-1.500 V	-100.0MV
58	8	-630.0MV	-1.500 V	-100.0MV
58	10	-620.0MV	-1.500 V	-100.0MV
58	12	-620.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-940.0MV	-1.500 V	
85	3	-910.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.950 V	2.500 V	
200	4	2.960 V	2.500 V	
206	6	2.950 V	2.500 V	
212	8	2.950 V	2.500 V	
218	10	2.950 V	2.500 V	
224	12	2.950 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	272.0MV		400.0MV
250	4	246.0MV		400.0MV
256	6	256.0MV		400.0MV
262	8	258.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	256.0MV		400.0MV



```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-45.00MA	-100.0MA	-20.00MA
306	4	-48.10MA	-100.0MA	-20.00MA
312	6	-46.30MA	-100.0MA	-20.00MA
318	8	-46.30MA	-100.0MA	-20.00MA
324	10	-44.50MA	-100.0MA	-20.00MA
330	12	-47.30MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-220.0UA	-400.0UA	
425	9	-220.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.530MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.780MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 4

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-490.0MV	-1.500 V	-100.0MV
58	3	-490.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-490.0MV	-1.500 V	-100.0MV
58	11	-490.0MV	-1.500 V	-100.0MV
58	13	-490.0MV	-1.500 V	-100.0MV
58	14	-550.0MV	-1.500 V	-100.0MV
58	2	-620.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-620.0MV	-1.500 V	-100.0MV
58	8	-620.0MV	-1.500 V	-100.0MV
58	10	-620.0MV	-1.500 V	-100.0MV
58	12	-620.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-940.0MV	-1.500 V	
85	3	-890.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-990.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.960 V	2.500 V	
200	4	2.960 V	2.500 V	
206	6	2.960 V	2.500 V	
212	8	2.950 V	2.500 V	
218	10	2.950 V	2.500 V	
224	12	2.950 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	276.0MV		400.0MV
250	4	248.0MV		400.0MV
256	6	258.0MV		400.0MV
262	8	276.0MV		400.0MV
268	10	274.0MV		400.0MV
274	12	256.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-45.10MA	-100.0MA	-20.00MA
306	4	-48.00MA	-100.0MA	-20.00MA
312	6	-46.20MA	-100.0MA	-20.00MA
318	8	-44.90MA	-100.0MA	-20.00MA
324	10	-44.60MA	-100.0MA	-20.00MA
330	12	-47.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-220.0UA	-400.0UA	
425	9	-220.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.540MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.790MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 5

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-500.0MV	-1.500 V	-100.0MV
58	3	-500.0MV	-1.500 V	-100.0MV
58	5	-500.0MV	-1.500 V	-100.0MV
58	9	-500.0MV	-1.500 V	-100.0MV
58	11	-500.0MV	-1.500 V	-100.0MV
58	13	-500.0MV	-1.500 V	-100.0MV
58	14	-570.0MV	-1.500 V	-100.0MV
58	2	-630.0MV	-1.500 V	-100.0MV
58	4	-630.0MV	-1.500 V	-100.0MV
58	6	-630.0MV	-1.500 V	-100.0MV
58	8	-640.0MV	-1.500 V	-100.0MV
58	10	-630.0MV	-1.500 V	-100.0MV
58	12	-630.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-950.0MV	-1.500 V	
85	3	-890.0MV	-1.500 V	
91	5	-920.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-910.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.940 V	2.500 V	
200	4	2.940 V	2.500 V	
206	6	2.940 V	2.500 V	
212	8	2.930 V	2.500 V	
218	10	2.930 V	2.500 V	
224	12	2.940 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	274.0MV		400.0MV
250	4	248.0MV		400.0MV
256	6	258.0MV		400.0MV
262	8	260.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	258.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-45.00MA	-100.0MA	-20.00MA
306	4	-48.10MA	-100.0MA	-20.00MA
312	6	-46.20MA	-100.0MA	-20.00MA
318	8	-46.30MA	-100.0MA	-20.00MA
324	10	-44.40MA	-100.0MA	-20.00MA
330	12	-47.40MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-220.0UA	-400.0UA	
425	9	-220.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.540MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.790MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 6

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-490.0MV	-1.500 V	-100.0MV
58	11	-490.0MV	-1.500 V	-100.0MV
58	13	-490.0MV	-1.500 V	-100.0MV
58	14	-550.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-620.0MV	-1.500 V	-100.0MV
58	8	-620.0MV	-1.500 V	-100.0MV
58	10	-620.0MV	-1.500 V	-100.0MV
58	12	-620.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-940.0MV	-1.500 V	
85	3	-880.0MV	-1.500 V	
91	5	-1.230 V	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-880.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.970 V	2.500 V	
200	4	2.970 V	2.500 V	
206	6	2.960 V	2.500 V	
212	8	2.970 V	2.500 V	
218	10	2.970 V	2.500 V	
224	12	2.970 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	274.0MV		400.0MV
250	4	246.0MV		400.0MV
256	6	258.0MV		400.0MV
262	8	256.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	256.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.50MA	-100.0MA	-20.00MA
306	4	-47.30MA	-100.0MA	-20.00MA
312	6	-45.40MA	-100.0MA	-20.00MA
318	8	-45.80MA	-100.0MA	-20.00MA
324	10	-43.90MA	-100.0MA	-20.00MA
330	12	-46.80MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.480MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.630MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 7

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-500.0MV	-1.500 V	-100.0MV
58	3	-500.0MV	-1.500 V	-100.0MV
58	5	-500.0MV	-1.500 V	-100.0MV
58	9	-500.0MV	-1.500 V	-100.0MV
58	11	-500.0MV	-1.500 V	-100.0MV
58	13	-500.0MV	-1.500 V	-100.0MV
58	14	-570.0MV	-1.500 V	-100.0MV
58	2	-630.0MV	-1.500 V	-100.0MV
58	4	-630.0MV	-1.500 V	-100.0MV
58	6	-640.0MV	-1.500 V	-100.0MV
58	8	-640.0MV	-1.500 V	-100.0MV
58	10	-640.0MV	-1.500 V	-100.0MV
58	12	-640.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-950.0MV	-1.500 V	
85	3	-930.0MV	-1.500 V	
91	5	-1.190 V	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.940 V	2.500 V	
200	4	2.940 V	2.500 V	
206	6	2.940 V	2.500 V	
212	8	2.930 V	2.500 V	
218	10	2.940 V	2.500 V	
224	12	2.940 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	276.0MV		400.0MV
250	4	248.0MV		400.0MV
256	6	258.0MV		400.0MV
262	8	312.0MV		400.0MV
268	10	274.0MV		400.0MV
274	12	256.0MV		400.0MV



```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.40MA	-100.0MA	-20.00MA
306	4	-47.80MA	-100.0MA	-20.00MA
312	6	-46.00MA	-100.0MA	-20.00MA
318	8	-43.30MA	-100.0MA	-20.00MA
324	10	-44.30MA	-100.0MA	-20.00MA
330	12	-47.30MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.490MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.650MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 8

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-500.0MV	-1.500 V	-100.0MV
58	3	-500.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-500.0MV	-1.500 V	-100.0MV
58	11	-500.0MV	-1.500 V	-100.0MV
58	13	-500.0MV	-1.500 V	-100.0MV
58	14	-570.0MV	-1.500 V	-100.0MV
58	2	-630.0MV	-1.500 V	-100.0MV
58	4	-630.0MV	-1.500 V	-100.0MV
58	6	-630.0MV	-1.500 V	-100.0MV
58	8	-640.0MV	-1.500 V	-100.0MV
58	10	-630.0MV	-1.500 V	-100.0MV
58	12	-630.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-960.0MV	-1.500 V	
85	3	-900.0MV	-1.500 V	
91	5	-930.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.940 V	2.500 V	
200	4	2.940 V	2.500 V	
206	6	2.930 V	2.500 V	
212	8	2.930 V	2.500 V	
218	10	2.930 V	2.500 V	
224	12	2.940 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	276.0MV		400.0MV
250	4	250.0MV		400.0MV
256	6	260.0MV		400.0MV
262	8	358.0MV		400.0MV
268	10	274.0MV		400.0MV
274	12	258.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.20MA	-100.0MA	-20.00MA
306	4	-47.90MA	-100.0MA	-20.00MA
312	6	-46.10MA	-100.0MA	-20.00MA
318	8	-43.60MA	-100.0MA	-20.00MA
324	10	-44.30MA	-100.0MA	-20.00MA
330	12	-47.40MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-220.0UA	-400.0UA	
425	9	-220.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.510MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.710MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 9

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-490.0MV	-1.500 V	-100.0MV
58	3	-490.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-490.0MV	-1.500 V	-100.0MV
58	11	-500.0MV	-1.500 V	-100.0MV
58	13	-490.0MV	-1.500 V	-100.0MV
58	14	-560.0MV	-1.500 V	-100.0MV
58	2	-630.0MV	-1.500 V	-100.0MV
58	4	-630.0MV	-1.500 V	-100.0MV
58	6	-630.0MV	-1.500 V	-100.0MV
58	8	-630.0MV	-1.500 V	-100.0MV
58	10	-630.0MV	-1.500 V	-100.0MV
58	12	-630.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-950.0MV	-1.500 V	
85	3	-910.0MV	-1.500 V	
91	5	-1.120 V	-1.500 V	
97	9	-990.0MV	-1.500 V	
103	11	-890.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.950 V	2.500 V	
200	4	2.950 V	2.500 V	
206	6	2.950 V	2.500 V	
212	8	2.950 V	2.500 V	
218	10	2.950 V	2.500 V	
224	12	2.950 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	276.0MV		400.0MV
250	4	248.0MV		400.0MV
256	6	258.0MV		400.0MV
262	8	318.0MV		400.0MV
268	10	274.0MV		400.0MV
274	12	256.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.00MA	-100.0MA	-20.00MA
306	4	-47.20MA	-100.0MA	-20.00MA
312	6	-45.50MA	-100.0MA	-20.00MA
318	8	-43.20MA	-100.0MA	-20.00MA
324	10	-43.90MA	-100.0MA	-20.00MA
330	12	-46.70MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.460MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.570MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 10

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-500.0MV	-1.500 V	-100.0MV
58	3	-490.0MV	-1.500 V	-100.0MV
58	5	-500.0MV	-1.500 V	-100.0MV
58	9	-500.0MV	-1.500 V	-100.0MV
58	11	-500.0MV	-1.500 V	-100.0MV
58	13	-500.0MV	-1.500 V	-100.0MV
58	14	-570.0MV	-1.500 V	-100.0MV
58	2	-630.0MV	-1.500 V	-100.0MV
58	4	-630.0MV	-1.500 V	-100.0MV
58	6	-630.0MV	-1.500 V	-100.0MV
58	8	-640.0MV	-1.500 V	-100.0MV
58	10	-640.0MV	-1.500 V	-100.0MV
58	12	-640.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-960.0MV	-1.500 V	
85	3	-930.0MV	-1.500 V	
91	5	-960.0MV	-1.500 V	
97	9	-990.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.930 V	2.500 V	
200	4	2.930 V	2.500 V	
206	6	2.920 V	2.500 V	
212	8	2.910 V	2.500 V	
218	10	2.920 V	2.500 V	
224	12	2.920 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	276.0MV		400.0MV
250	4	250.0MV		400.0MV
256	6	260.0MV		400.0MV
262	8	358.0MV		400.0MV
268	10	274.0MV		400.0MV
274	12	256.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.70MA	-100.0MA	-20.00MA
306	4	-47.90MA	-100.0MA	-20.00MA
312	6	-46.40MA	-100.0MA	-20.00MA
318	8	-43.90MA	-100.0MA	-20.00MA
324	10	-44.40MA	-100.0MA	-20.00MA
330	12	-47.80MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-220.0UA	-400.0UA	
425	9	-220.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.550MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.810MA		6.600MA

```

EIR 1.....10      FCT      DCT
    0000000000     PASS     PASS     EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 11

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-490.0MV	-1.500 V	-100.0MV
58	3	-490.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-490.0MV	-1.500 V	-100.0MV
58	11	-490.0MV	-1.500 V	-100.0MV
58	13	-490.0MV	-1.500 V	-100.0MV
58	14	-560.0MV	-1.500 V	-100.0MV
58	2	-620.0MV	-1.500 V	-100.0MV
58	4	-630.0MV	-1.500 V	-100.0MV
58	6	-630.0MV	-1.500 V	-100.0MV
58	8	-1.020 V	-1.500 V	-100.0MV
58	10	-630.0MV	-1.500 V	-100.0MV
58	12	-630.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-960.0MV	-1.500 V	
85	3	-920.0MV	-1.500 V	
91	5	-1.040 V	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.940 V	2.500 V	
200	4	2.940 V	2.500 V	
206	6	2.940 V	2.500 V	
212	8	2.930 V	2.500 V	
218	10	2.940 V	2.500 V	
224	12	2.940 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	274.0MV		400.0MV
250	4	248.0MV		400.0MV
256	6	260.0MV		400.0MV
262	8	400.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	256.0MV		400.0MV



```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.70MA	-100.0MA	-20.00MA
306	4	-48.30MA	-100.0MA	-20.00MA
312	6	-46.30MA	-100.0MA	-20.00MA
318	8	-43.90MA	-100.0MA	-20.00MA
324	10	-44.70MA	-100.0MA	-20.00MA
330	12	-47.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-220.0UA	-400.0UA	
425	9	-220.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.550MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.840MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 12

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 -55C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-490.0MV	-1.500 V	-100.0MV
58	3	-490.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-490.0MV	-1.500 V	-100.0MV
58	11	-490.0MV	-1.500 V	-100.0MV
58	13	-490.0MV	-1.500 V	-100.0MV
58	14	-550.0MV	-1.500 V	-100.0MV
58	2	-620.0MV	-1.500 V	-100.0MV
58	4	-620.0MV	-1.500 V	-100.0MV
58	6	-620.0MV	-1.500 V	-100.0MV
58	8	-620.0MV	-1.500 V	-100.0MV
58	10	-620.0MV	-1.500 V	-100.0MV
58	12	-620.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-960.0MV	-1.500 V	
85	3	-910.0MV	-1.500 V	
91	5	-1.160 V	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-900.0MV	-1.500 V	
109	13	-890.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.950 V	2.500 V	
200	4	2.950 V	2.500 V	
206	6	2.950 V	2.500 V	
212	8	2.940 V	2.500 V	
218	10	2.950 V	2.500 V	
224	12	2.940 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	272.0MV		400.0MV
250	4	248.0MV		400.0MV
256	6	258.0MV		400.0MV
262	8	326.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	258.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.20MA	-100.0MA	-20.00MA
306	4	-47.30MA	-100.0MA	-20.00MA
312	6	-45.60MA	-100.0MA	-20.00MA
318	8	-43.40MA	-100.0MA	-20.00MA
324	10	-43.90MA	-100.0MA	-20.00MA
330	12	-47.00MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-220.0UA	-400.0UA	
417	3	-220.0UA	-400.0UA	
421	5	-220.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-220.0UA	-400.0UA	
433	13	-220.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.500MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.680MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```



# MIL-PRF-38534 CLASS K DATAPACK

---

Post Burn-In Test Results at 25°C



STAT1 08/20/11 04:50  
 TEST PROGRAM 4LS04 S/N 1  
 DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
 CONTINUITY TEST  
 -----

INST #	PIN	MEASURED	LT	GT
58	1	-470.0MV	-1.500 V	-100.0MV
58	3	-470.0MV	-1.500 V	-100.0MV
58	5	-470.0MV	-1.500 V	-100.0MV
58	9	-470.0MV	-1.500 V	-100.0MV
58	11	-470.0MV	-1.500 V	-100.0MV
58	13	-470.0MV	-1.500 V	-100.0MV
58	14	-520.0MV	-1.500 V	-100.0MV
58	2	-600.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-590.0MV	-1.500 V	-100.0MV
58	8	-600.0MV	-1.500 V	-100.0MV
58	10	-600.0MV	-1.500 V	-100.0MV
58	12	-600.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-890.0MV	-1.500 V	
85	3	-860.0MV	-1.500 V	
91	5	-950.0MV	-1.500 V	
97	9	-990.0MV	-1.500 V	
103	11	-870.0MV	-1.500 V	
109	13	-870.0MV	-1.500 V	

-----  
 FUNCTIONAL TEST  
 VCC= 4.500  
 VIH= 2 VIL= 700.0E-03  
 -----

-----  
 VOH TEST  
 VCC= 4.500  
 VOH LIMIT 2.500  
 -----

INST #	PIN	MEASURED	LT	GT
194	2	3.010 V	2.500 V	
200	4	3.010 V	2.500 V	
206	6	3.010 V	2.500 V	
212	8	3.010 V	2.500 V	
218	10	3.010 V	2.500 V	
224	12	3.020 V	2.500 V	

-----  
 VOL TEST  
 VCC= 4.500  
 VOL LIMIT 400.0E-03  
 -----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	250.0MV		400.0MV
268	10	260.0MV		400.0MV
274	12	250.0MV		400.0MV

-----

FUNCTIONAL TEST  
VCC= 5.500  
VIH= 2 VIL= 700.0E-03

-----  
IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.10MA	-100.0MA	-20.00MA
306	4	-46.40MA	-100.0MA	-20.00MA
312	6	-44.50MA	-100.0MA	-20.00MA
318	8	-44.40MA	-100.0MA	-20.00MA
324	10	-43.90MA	-100.0MA	-20.00MA
330	12	-45.70MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

IIIL TEST -400UA MAXVIN=0.4VCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.420MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.480MA		6.600MA

EIR 1.....10 FCT DCT  
0000000000 PASS PASS EOT

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 2

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-960.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-880.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	268.0MV		400.0MV
250	4	244.0MV		400.0MV
256	6	258.0MV		400.0MV
262	8	258.0MV		400.0MV
268	10	266.0MV		400.0MV
274	12	250.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.40MA	-100.0MA	-20.00MA
306	4	-46.50MA	-100.0MA	-20.00MA
312	6	-44.70MA	-100.0MA	-20.00MA
318	8	-44.80MA	-100.0MA	-20.00MA
324	10	-44.20MA	-100.0MA	-20.00MA
330	12	-46.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.440MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.490MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```



STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 3

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-490.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-620.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-880.0MV	-1.500 V	
91	5	-960.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-880.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.980 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	268.0MV		400.0MV
250	4	246.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	304.0MV		400.0MV
268	10	268.0MV		400.0MV
274	12	252.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.60MA	-100.0MA	-20.00MA
306	4	-47.00MA	-100.0MA	-20.00MA
312	6	-45.00MA	-100.0MA	-20.00MA
318	8	-42.50MA	-100.0MA	-20.00MA
324	10	-44.60MA	-100.0MA	-20.00MA
330	12	-46.30MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.450MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.560MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 4

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-970.0MV	-1.500 V	
97	9	-970.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-870.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	268.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	258.0MV		400.0MV
268	10	272.0MV		400.0MV
274	12	248.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.70MA	-100.0MA	-20.00MA
306	4	-47.10MA	-100.0MA	-20.00MA
312	6	-45.10MA	-100.0MA	-20.00MA
318	8	-44.40MA	-100.0MA	-20.00MA
324	10	-44.20MA	-100.0MA	-20.00MA
330	12	-46.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.460MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.590MA		6.600MA

```

EIR 1.....10 FCT DCT
0000000000 PASS PASS EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 5

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-970.0MV	-1.500 V	
97	9	-970.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-880.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	256.0MV		400.0MV
262	8	258.0MV		400.0MV
268	10	278.0MV		400.0MV
274	12	252.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.40MA	-100.0MA	-20.00MA
306	4	-46.80MA	-100.0MA	-20.00MA
312	6	-44.80MA	-100.0MA	-20.00MA
318	8	-44.50MA	-100.0MA	-20.00MA
324	10	-43.60MA	-100.0MA	-20.00MA
330	12	-46.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.440MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.540MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 6

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-910.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-980.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-880.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	3 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	3 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	252.0MV		400.0MV
262	8	254.0MV		400.0MV
268	10	304.0MV		400.0MV
274	12	252.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.30MA	-100.0MA	-20.00MA
306	4	-46.60MA	-100.0MA	-20.00MA
312	6	-44.90MA	-100.0MA	-20.00MA
318	8	-45.10MA	-100.0MA	-20.00MA
324	10	-43.50MA	-100.0MA	-20.00MA
330	12	-46.00MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.410MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.450MA		6.600MA

```

EIR 1.....10 FCT DCT
0000000000 PASS PASS EOT

```



STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 7

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-960.0MV	-1.500 V	
97	9	-970.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-880.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	2.990 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	264.0MV		400.0MV
250	4	240.0MV		400.0MV
256	6	252.0MV		400.0MV
262	8	262.0MV		400.0MV
268	10	280.0MV		400.0MV
274	12	250.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.50MA	-100.0MA	-20.00MA
306	4	-46.80MA	-100.0MA	-20.00MA
312	6	-45.10MA	-100.0MA	-20.00MA
318	8	-44.30MA	-100.0MA	-20.00MA
324	10	-43.70MA	-100.0MA	-20.00MA
330	12	-46.20MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	0 A		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.430MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.480MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 8

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-970.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-880.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	3 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	3 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	256.0MV		400.0MV
262	8	256.0MV		400.0MV
268	10	290.0MV		400.0MV
274	12	250.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.30MA	-100.0MA	-20.00MA
306	4	-46.60MA	-100.0MA	-20.00MA
312	6	-44.90MA	-100.0MA	-20.00MA
318	8	-44.70MA	-100.0MA	-20.00MA
324	10	-43.50MA	-100.0MA	-20.00MA
330	12	-46.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.410MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.450MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 9

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-960.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-880.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	2.990 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	3 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	244.0MV		400.0MV
256	6	256.0MV		400.0MV
262	8	264.0MV		400.0MV
268	10	298.0MV		400.0MV
274	12	252.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.30MA	-100.0MA	-20.00MA
306	4	-46.50MA	-100.0MA	-20.00MA
312	6	-44.70MA	-100.0MA	-20.00MA
318	8	-43.80MA	-100.0MA	-20.00MA
324	10	-43.30MA	-100.0MA	-20.00MA
330	12	-46.00MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.410MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.440MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 10

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-530.0MV	-1.500 V	-100.0MV
58	2	-600.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-600.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-600.0MV	-1.500 V	-100.0MV
58	12	-600.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-860.0MV	-1.500 V	
91	5	-960.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-870.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3 V	2.500 V	
200	4	3 V	2.500 V	
206	6	3 V	2.500 V	
212	8	3 V	2.500 V	
218	10	3 V	2.500 V	
224	12	3 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	264.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	252.0MV		400.0MV
262	8	262.0MV		400.0MV
268	10	306.0MV		400.0MV
274	12	250.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.40MA	-100.0MA	-20.00MA
306	4	-46.30MA	-100.0MA	-20.00MA
312	6	-44.90MA	-100.0MA	-20.00MA
318	8	-44.30MA	-100.0MA	-20.00MA
324	10	-43.00MA	-100.0MA	-20.00MA
330	12	-46.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.430MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.500MA		6.600MA

```

EIR 1.....10      FCT   DCT
    0000000000    PASS  PASS  EOT

```



STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 11

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-600.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-600.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-600.0MV	-1.500 V	-100.0MV
58	12	-600.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-970.0MV	-1.500 V	
97	9	-970.0MV	-1.500 V	
103	11	-870.0MV	-1.500 V	
109	13	-870.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3 V	2.500 V	
200	4	3 V	2.500 V	
206	6	3 V	2.500 V	
212	8	3 V	2.500 V	
218	10	3 V	2.500 V	
224	12	3 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	252.0MV		400.0MV
262	8	284.0MV		400.0MV
268	10	282.0MV		400.0MV
274	12	250.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.40MA	-100.0MA	-20.00MA
306	4	-46.90MA	-100.0MA	-20.00MA
312	6	-44.90MA	-100.0MA	-20.00MA
318	8	-43.20MA	-100.0MA	-20.00MA
324	10	-43.50MA	-100.0MA	-20.00MA
330	12	-46.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.440MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.550MA		6.600MA

```

EIR 1.....10      FCT   DCT
    0000000000    PASS  PASS  EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 12

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +25C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-480.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-480.0MV	-1.500 V	-100.0MV
58	13	-480.0MV	-1.500 V	-100.0MV
58	14	-540.0MV	-1.500 V	-100.0MV
58	2	-610.0MV	-1.500 V	-100.0MV
58	4	-610.0MV	-1.500 V	-100.0MV
58	6	-610.0MV	-1.500 V	-100.0MV
58	8	-610.0MV	-1.500 V	-100.0MV
58	10	-610.0MV	-1.500 V	-100.0MV
58	12	-610.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-900.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-970.0MV	-1.500 V	
97	9	-970.0MV	-1.500 V	
103	11	-880.0MV	-1.500 V	
109	13	-870.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	2.990 V	2.500 V	
200	4	3 V	2.500 V	
206	6	2.990 V	2.500 V	
212	8	2.990 V	2.500 V	
218	10	2.990 V	2.500 V	
224	12	3 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	264.0MV		400.0MV
250	4	244.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	302.0MV		400.0MV
268	10	302.0MV		400.0MV
274	12	250.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-44.30MA	-100.0MA	-20.00MA
306	4	-46.30MA	-100.0MA	-20.00MA
312	6	-44.50MA	-100.0MA	-20.00MA
318	8	-43.10MA	-100.0MA	-20.00MA
324	10	-43.10MA	-100.0MA	-20.00MA
330	12	-46.00MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.410MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.420MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```



# MIL-PRF-38534 CLASS K DATAPACK

---

Post Burn-In Test Results at +125°C



STAT1 08/20/11 04:50  
 TEST PROGRAM 4LS04 S/N 1  
 DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
 CONTINUITY TEST  
 -----

INST #	PIN	MEASURED	LT	GT
58	1	-470.0MV	-1.500 V	-100.0MV
58	3	-460.0MV	-1.500 V	-100.0MV
58	5	-460.0MV	-1.500 V	-100.0MV
58	9	-460.0MV	-1.500 V	-100.0MV
58	11	-460.0MV	-1.500 V	-100.0MV
58	13	-460.0MV	-1.500 V	-100.0MV
58	14	-510.0MV	-1.500 V	-100.0MV
58	2	-580.0MV	-1.500 V	-100.0MV
58	4	-570.0MV	-1.500 V	-100.0MV
58	6	-570.0MV	-1.500 V	-100.0MV
58	8	-580.0MV	-1.500 V	-100.0MV
58	10	-570.0MV	-1.500 V	-100.0MV
58	12	-570.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-920.0MV	-1.500 V	
85	3	-890.0MV	-1.500 V	
91	5	-1.060 V	-1.500 V	
97	9	-940.0MV	-1.500 V	
103	11	-850.0MV	-1.500 V	
109	13	-850.0MV	-1.500 V	

-----  
 FUNCTIONAL TEST  
 VCC= 4.500  
 VIH= 2 VIL= 700.0E-03  
 -----

-----  
 VOH TEST  
 VCC= 4.500  
 VOH LIMIT 2.500  
 -----

INST #	PIN	MEASURED	LT	GT
194	2	3.080 V	2.500 V	
200	4	3.080 V	2.500 V	
206	6	3.080 V	2.500 V	
212	8	3.080 V	2.500 V	
218	10	3.080 V	2.500 V	
224	12	3.090 V	2.500 V	

-----  
 VOL TEST  
 VCC= 4.500  
 VOL LIMIT 400.0E-03  
 -----

INST #	PIN	MEASURED	LT	GT
244	2	262.0MV		400.0MV
250	4	234.0MV		400.0MV
256	6	246.0MV		400.0MV
262	8	266.0MV		400.0MV
268	10	258.0MV		400.0MV
274	12	244.0MV		400.0MV

-----

FUNCTIONAL TEST  
VCC= 5.500  
VIH= 2 VIL= 700.0E-03

---

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-41.90MA	-100.0MA	-20.00MA
306	4	-44.60MA	-100.0MA	-20.00MA
312	6	-43.00MA	-100.0MA	-20.00MA
318	8	-40.20MA	-100.0MA	-20.00MA
324	10	-41.30MA	-100.0MA	-20.00MA
330	12	-43.80MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-190.0UA	-400.0UA	
417	3	-190.0UA	-400.0UA	
421	5	-180.0UA	-400.0UA	
425	9	-190.0UA	-400.0UA	
429	11	-190.0UA	-400.0UA	
433	13	-190.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.290MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.120MA		6.600MA

EIR 1.....10 FCT DCT  
0000000000 PASS PASS EOT

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 2

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-470.0MV	-1.500 V	-100.0MV
58	3	-470.0MV	-1.500 V	-100.0MV
58	5	-470.0MV	-1.500 V	-100.0MV
58	9	-470.0MV	-1.500 V	-100.0MV
58	11	-470.0MV	-1.500 V	-100.0MV
58	13	-470.0MV	-1.500 V	-100.0MV
58	14	-530.0MV	-1.500 V	-100.0MV
58	2	-590.0MV	-1.500 V	-100.0MV
58	4	-590.0MV	-1.500 V	-100.0MV
58	6	-590.0MV	-1.500 V	-100.0MV
58	8	-600.0MV	-1.500 V	-100.0MV
58	10	-590.0MV	-1.500 V	-100.0MV
58	12	-590.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-930.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-1.130 V	-1.500 V	
97	9	-970.0MV	-1.500 V	
103	11	-870.0MV	-1.500 V	
109	13	-870.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.020 V	2.500 V	
200	4	3.020 V	2.500 V	
206	6	3.020 V	2.500 V	
212	8	3.020 V	2.500 V	
218	10	3.020 V	2.500 V	
224	12	3.020 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	252.0MV		400.0MV
262	8	360.0MV		400.0MV
268	10	264.0MV		400.0MV
274	12	250.0MV		400.0MV



```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-43.10MA	-100.0MA	-20.00MA
306	4	-45.90MA	-100.0MA	-20.00MA
312	6	-44.20MA	-100.0MA	-20.00MA
318	8	-42.30MA	-100.0MA	-20.00MA
324	10	-42.50MA	-100.0MA	-20.00MA
330	12	-45.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.390MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.360MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 3

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-470.0MV	-1.500 V	-100.0MV
58	5	-470.0MV	-1.500 V	-100.0MV
58	9	-470.0MV	-1.500 V	-100.0MV
58	11	-470.0MV	-1.500 V	-100.0MV
58	13	-470.0MV	-1.500 V	-100.0MV
58	14	-530.0MV	-1.500 V	-100.0MV
58	2	-590.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-600.0MV	-1.500 V	-100.0MV
58	8	-600.0MV	-1.500 V	-100.0MV
58	10	-590.0MV	-1.500 V	-100.0MV
58	12	-590.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-970.0MV	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-910.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-870.0MV	-1.500 V	
109	13	-870.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.020 V	2.500 V	
200	4	3.030 V	2.500 V	
206	6	3.020 V	2.500 V	
212	8	3.030 V	2.500 V	
218	10	3.030 V	2.500 V	
224	12	3.030 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	240.0MV		400.0MV
256	6	254.0MV		400.0MV
262	8	252.0MV		400.0MV
268	10	262.0MV		400.0MV
274	12	248.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-43.10MA	-100.0MA	-20.00MA
306	4	-46.20MA	-100.0MA	-20.00MA
312	6	-44.20MA	-100.0MA	-20.00MA
318	8	-44.00MA	-100.0MA	-20.00MA
324	10	-42.70MA	-100.0MA	-20.00MA
330	12	-45.50MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.400MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.410MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 4

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-470.0MV	-1.500 V	-100.0MV
58	5	-470.0MV	-1.500 V	-100.0MV
58	9	-480.0MV	-1.500 V	-100.0MV
58	11	-470.0MV	-1.500 V	-100.0MV
58	13	-470.0MV	-1.500 V	-100.0MV
58	14	-530.0MV	-1.500 V	-100.0MV
58	2	-600.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-600.0MV	-1.500 V	-100.0MV
58	8	-600.0MV	-1.500 V	-100.0MV
58	10	-600.0MV	-1.500 V	-100.0MV
58	12	-600.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.130 V	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-880.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-870.0MV	-1.500 V	
109	13	-870.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.010 V	2.500 V	
200	4	3.010 V	2.500 V	
206	6	3.010 V	2.500 V	
212	8	3.010 V	2.500 V	
218	10	3.010 V	2.500 V	
224	12	3.010 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	240.0MV		400.0MV
256	6	264.0MV		400.0MV
262	8	256.0MV		400.0MV
268	10	264.0MV		400.0MV
274	12	248.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-43.50MA	-100.0MA	-20.00MA
306	4	-46.70MA	-100.0MA	-20.00MA
312	6	-45.10MA	-100.0MA	-20.00MA
318	8	-43.70MA	-100.0MA	-20.00MA
324	10	-43.10MA	-100.0MA	-20.00MA
330	12	-46.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-210.0UA	-400.0UA	
417	3	-210.0UA	-400.0UA	
421	5	-210.0UA	-400.0UA	
425	9	-210.0UA	-400.0UA	
429	11	-210.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.430MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.490MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 5

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-480.0MV	-1.500 V	-100.0MV
58	3	-480.0MV	-1.500 V	-100.0MV
58	5	-470.0MV	-1.500 V	-100.0MV
58	9	-470.0MV	-1.500 V	-100.0MV
58	11	-470.0MV	-1.500 V	-100.0MV
58	13	-470.0MV	-1.500 V	-100.0MV
58	14	-530.0MV	-1.500 V	-100.0MV
58	2	-600.0MV	-1.500 V	-100.0MV
58	4	-600.0MV	-1.500 V	-100.0MV
58	6	-600.0MV	-1.500 V	-100.0MV
58	8	-600.0MV	-1.500 V	-100.0MV
58	10	-600.0MV	-1.500 V	-100.0MV
58	12	-600.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.140 V	-1.500 V	
85	3	-880.0MV	-1.500 V	
91	5	-980.0MV	-1.500 V	
97	9	-980.0MV	-1.500 V	
103	11	-870.0MV	-1.500 V	
109	13	-880.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.010 V	2.500 V	
200	4	3.020 V	2.500 V	
206	6	3.010 V	2.500 V	
212	8	3.020 V	2.500 V	
218	10	3.010 V	2.500 V	
224	12	3.010 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	270.0MV		400.0MV
250	4	246.0MV		400.0MV
256	6	256.0MV		400.0MV
262	8	252.0MV		400.0MV
268	10	268.0MV		400.0MV
274	12	250.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-43.40MA	-100.0MA	-20.00MA
306	4	-46.00MA	-100.0MA	-20.00MA
312	6	-45.10MA	-100.0MA	-20.00MA
318	8	-44.70MA	-100.0MA	-20.00MA
324	10	-43.00MA	-100.0MA	-20.00MA
330	12	-45.80MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-210.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.420MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.470MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 6

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-470.0MV	-1.500 V	-100.0MV
58	3	-470.0MV	-1.500 V	-100.0MV
58	5	-470.0MV	-1.500 V	-100.0MV
58	9	-470.0MV	-1.500 V	-100.0MV
58	11	-470.0MV	-1.500 V	-100.0MV
58	13	-470.0MV	-1.500 V	-100.0MV
58	14	-520.0MV	-1.500 V	-100.0MV
58	2	-590.0MV	-1.500 V	-100.0MV
58	4	-590.0MV	-1.500 V	-100.0MV
58	6	-590.0MV	-1.500 V	-100.0MV
58	8	-590.0MV	-1.500 V	-100.0MV
58	10	-590.0MV	-1.500 V	-100.0MV
58	12	-590.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.210 V	-1.500 V	
85	3	-920.0MV	-1.500 V	
91	5	-910.0MV	-1.500 V	
97	9	-1.020 V	-1.500 V	
103	11	-910.0MV	-1.500 V	
109	13	-910.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.030 V	2.500 V	
200	4	3.040 V	2.500 V	
206	6	3.040 V	2.500 V	
212	8	3.040 V	2.500 V	
218	10	3.030 V	2.500 V	
224	12	3.040 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	284.0MV		400.0MV
250	4	258.0MV		400.0MV
256	6	268.0MV		400.0MV
262	8	264.0MV		400.0MV
268	10	284.0MV		400.0MV
274	12	268.0MV		400.0MV



```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.90MA	-100.0MA	-20.00MA
306	4	-45.50MA	-100.0MA	-20.00MA
312	6	-44.00MA	-100.0MA	-20.00MA
318	8	-44.00MA	-100.0MA	-20.00MA
324	10	-42.40MA	-100.0MA	-20.00MA
330	12	-45.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-200.0UA	-400.0UA	
417	3	-200.0UA	-400.0UA	
421	5	-200.0UA	-400.0UA	
425	9	-200.0UA	-400.0UA	
429	11	-200.0UA	-400.0UA	
433	13	-200.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.350MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.270MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 7

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-460.0MV	-1.500 V	-100.0MV
58	3	-460.0MV	-1.500 V	-100.0MV
58	5	-460.0MV	-1.500 V	-100.0MV
58	9	-460.0MV	-1.500 V	-100.0MV
58	11	-460.0MV	-1.500 V	-100.0MV
58	13	-460.0MV	-1.500 V	-100.0MV
58	14	-510.0MV	-1.500 V	-100.0MV
58	2	-580.0MV	-1.500 V	-100.0MV
58	4	-580.0MV	-1.500 V	-100.0MV
58	6	-580.0MV	-1.500 V	-100.0MV
58	8	-580.0MV	-1.500 V	-100.0MV
58	10	-570.0MV	-1.500 V	-100.0MV
58	12	-570.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.140 V	-1.500 V	
85	3	-860.0MV	-1.500 V	
91	5	-910.0MV	-1.500 V	
97	9	-960.0MV	-1.500 V	
103	11	-860.0MV	-1.500 V	
109	13	-860.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.060 V	2.500 V	
200	4	3.060 V	2.500 V	
206	6	3.060 V	2.500 V	
212	8	3.060 V	2.500 V	
218	10	3.060 V	2.500 V	
224	12	3.060 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	262.0MV		400.0MV
250	4	238.0MV		400.0MV
256	6	248.0MV		400.0MV
262	8	248.0MV		400.0MV
268	10	264.0MV		400.0MV
274	12	244.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-42.10MA	-100.0MA	-20.00MA
306	4	-44.50MA	-100.0MA	-20.00MA
312	6	-43.50MA	-100.0MA	-20.00MA
318	8	-43.20MA	-100.0MA	-20.00MA
324	10	-41.50MA	-100.0MA	-20.00MA
330	12	-44.10MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-190.0UA	-400.0UA	
417	3	-190.0UA	-400.0UA	
421	5	-190.0UA	-400.0UA	
425	9	-190.0UA	-400.0UA	
429	11	-190.0UA	-400.0UA	
433	13	-190.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.310MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.160MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 8

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-460.0MV	-1.500 V	-100.0MV
58	3	-460.0MV	-1.500 V	-100.0MV
58	5	-460.0MV	-1.500 V	-100.0MV
58	9	-460.0MV	-1.500 V	-100.0MV
58	11	-460.0MV	-1.500 V	-100.0MV
58	13	-460.0MV	-1.500 V	-100.0MV
58	14	-500.0MV	-1.500 V	-100.0MV
58	2	-570.0MV	-1.500 V	-100.0MV
58	4	-570.0MV	-1.500 V	-100.0MV
58	6	-570.0MV	-1.500 V	-100.0MV
58	8	-570.0MV	-1.500 V	-100.0MV
58	10	-570.0MV	-1.500 V	-100.0MV
58	12	-570.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.220 V	-1.500 V	
85	3	-860.0MV	-1.500 V	
91	5	-930.0MV	-1.500 V	
97	9	-960.0MV	-1.500 V	
103	11	-860.0MV	-1.500 V	
109	13	-860.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.060 V	2.500 V	
200	4	3.060 V	2.500 V	
206	6	3.060 V	2.500 V	
212	8	3.060 V	2.500 V	
218	10	3.060 V	2.500 V	
224	12	3.070 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	266.0MV		400.0MV
250	4	240.0MV		400.0MV
256	6	246.0MV		400.0MV
262	8	252.0MV		400.0MV
268	10	264.0MV		400.0MV
274	12	244.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-41.50MA	-100.0MA	-20.00MA
306	4	-43.80MA	-100.0MA	-20.00MA
312	6	-42.60MA	-100.0MA	-20.00MA
318	8	-42.50MA	-100.0MA	-20.00MA
324	10	-41.00MA	-100.0MA	-20.00MA
330	12	-43.60MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-190.0UA	-400.0UA	
417	3	-190.0UA	-400.0UA	
421	5	-190.0UA	-400.0UA	
425	9	-190.0UA	-400.0UA	
429	11	-190.0UA	-400.0UA	
433	13	-190.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.320MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.170MA		6.600MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 9

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-470.0MV	-1.500 V	-100.0MV
58	3	-470.0MV	-1.500 V	-100.0MV
58	5	-470.0MV	-1.500 V	-100.0MV
58	9	-470.0MV	-1.500 V	-100.0MV
58	11	-470.0MV	-1.500 V	-100.0MV
58	13	-470.0MV	-1.500 V	-100.0MV
58	14	-510.0MV	-1.500 V	-100.0MV
58	2	-580.0MV	-1.500 V	-100.0MV
58	4	-580.0MV	-1.500 V	-100.0MV
58	6	-580.0MV	-1.500 V	-100.0MV
58	8	-580.0MV	-1.500 V	-100.0MV
58	10	-580.0MV	-1.500 V	-100.0MV
58	12	-580.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.190 V	-1.500 V	
85	3	-870.0MV	-1.500 V	
91	5	-910.0MV	-1.500 V	
97	9	-960.0MV	-1.500 V	
103	11	-860.0MV	-1.500 V	
109	13	-860.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.050 V	2.500 V	
200	4	3.060 V	2.500 V	
206	6	3.060 V	2.500 V	
212	8	3.060 V	2.500 V	
218	10	3.060 V	2.500 V	
224	12	3.060 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	264.0MV		400.0MV
250	4	240.0MV		400.0MV
256	6	246.0MV		400.0MV
262	8	244.0MV		400.0MV
268	10	268.0MV		400.0MV
274	12	246.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-40.60MA	-100.0MA	-20.00MA
306	4	-42.80MA	-100.0MA	-20.00MA
312	6	-42.10MA	-100.0MA	-20.00MA
318	8	-41.90MA	-100.0MA	-20.00MA
324	10	-39.90MA	-100.0MA	-20.00MA
330	12	-42.60MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-190.0UA	-400.0UA	
417	3	-190.0UA	-400.0UA	
421	5	-190.0UA	-400.0UA	
425	9	-190.0UA	-400.0UA	
429	11	-190.0UA	-400.0UA	
433	13	-190.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.300MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.110MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 10

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-450.0MV	-1.500 V	-100.0MV
58	3	-450.0MV	-1.500 V	-100.0MV
58	5	-450.0MV	-1.500 V	-100.0MV
58	9	-450.0MV	-1.500 V	-100.0MV
58	11	-440.0MV	-1.500 V	-100.0MV
58	13	-440.0MV	-1.500 V	-100.0MV
58	14	-480.0MV	-1.500 V	-100.0MV
58	2	-550.0MV	-1.500 V	-100.0MV
58	4	-550.0MV	-1.500 V	-100.0MV
58	6	-550.0MV	-1.500 V	-100.0MV
58	8	-550.0MV	-1.500 V	-100.0MV
58	10	-550.0MV	-1.500 V	-100.0MV
58	12	-550.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.200 V	-1.500 V	
85	3	-850.0MV	-1.500 V	
91	5	-890.0MV	-1.500 V	
97	9	-940.0MV	-1.500 V	
103	11	-850.0MV	-1.500 V	
109	13	-850.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.100 V	2.500 V	
200	4	3.100 V	2.500 V	
206	6	3.100 V	2.500 V	
212	8	3.100 V	2.500 V	
218	10	3.100 V	2.500 V	
224	12	3.110 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	260.0MV		400.0MV
250	4	236.0MV		400.0MV
256	6	240.0MV		400.0MV
262	8	276.0MV		400.0MV
268	10	258.0MV		400.0MV
274	12	240.0MV		400.0MV



```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-40.00MA	-100.0MA	-20.00MA
306	4	-41.80MA	-100.0MA	-20.00MA
312	6	-41.20MA	-100.0MA	-20.00MA
318	8	-38.30MA	-100.0MA	-20.00MA
324	10	-38.90MA	-100.0MA	-20.00MA
330	12	-41.60MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-180.0UA	-400.0UA	
417	3	-180.0UA	-400.0UA	
421	5	-180.0UA	-400.0UA	
425	9	-180.0UA	-400.0UA	
429	11	-180.0UA	-400.0UA	
433	13	-180.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.260MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.020MA		6.600MA

```

EIR 1.....10    FCT    DCT
      0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 11

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-460.0MV	-1.500 V	-100.0MV
58	3	-460.0MV	-1.500 V	-100.0MV
58	5	-450.0MV	-1.500 V	-100.0MV
58	9	-460.0MV	-1.500 V	-100.0MV
58	11	-450.0MV	-1.500 V	-100.0MV
58	13	-450.0MV	-1.500 V	-100.0MV
58	14	-490.0MV	-1.500 V	-100.0MV
58	2	-570.0MV	-1.500 V	-100.0MV
58	4	-560.0MV	-1.500 V	-100.0MV
58	6	-570.0MV	-1.500 V	-100.0MV
58	8	-570.0MV	-1.500 V	-100.0MV
58	10	-560.0MV	-1.500 V	-100.0MV
58	12	-560.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.220 V	-1.500 V	
85	3	-860.0MV	-1.500 V	
91	5	-940.0MV	-1.500 V	
97	9	-950.0MV	-1.500 V	
103	11	-850.0MV	-1.500 V	
109	13	-850.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.080 V	2.500 V	
200	4	3.080 V	2.500 V	
206	6	3.090 V	2.500 V	
212	8	3.090 V	2.500 V	
218	10	3.080 V	2.500 V	
224	12	3.090 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	262.0MV		400.0MV
250	4	238.0MV		400.0MV
256	6	244.0MV		400.0MV
262	8	254.0MV		400.0MV
268	10	256.0MV		400.0MV
274	12	242.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-41.30MA	-100.0MA	-20.00MA
306	4	-43.60MA	-100.0MA	-20.00MA
312	6	-42.50MA	-100.0MA	-20.00MA
318	8	-41.80MA	-100.0MA	-20.00MA
324	10	-40.70MA	-100.0MA	-20.00MA
330	12	-43.20MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-190.0UA	-400.0UA	
417	3	-190.0UA	-400.0UA	
421	5	-190.0UA	-400.0UA	
425	9	-190.0UA	-400.0UA	
429	11	-190.0UA	-400.0UA	
433	13	-190.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.300MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.140MA		6.600MA

```

EIR 1.....10    FCT    DCT
    0000000000    PASS    PASS    EOT

```

STAT1 08/20/11 04:50  
TEST PROGRAM 4LS04 S/N 12

DDS-101-14-A PN 54LS04 ELECTRICAL TEST SEQ 14 +125C

-----  
CONTINUITY TEST  
-----

INST #	PIN	MEASURED	LT	GT
58	1	-470.0MV	-1.500 V	-100.0MV
58	3	-460.0MV	-1.500 V	-100.0MV
58	5	-470.0MV	-1.500 V	-100.0MV
58	9	-460.0MV	-1.500 V	-100.0MV
58	11	-460.0MV	-1.500 V	-100.0MV
58	13	-460.0MV	-1.500 V	-100.0MV
58	14	-510.0MV	-1.500 V	-100.0MV
58	2	-580.0MV	-1.500 V	-100.0MV
58	4	-580.0MV	-1.500 V	-100.0MV
58	6	-580.0MV	-1.500 V	-100.0MV
58	8	-580.0MV	-1.500 V	-100.0MV
58	10	-580.0MV	-1.500 V	-100.0MV
58	12	-580.0MV	-1.500 V	-100.0MV

VIK TEST -1.5V MINIIN=-18MAVCC=4.5V

INST #	PIN	MEASURED	LT	GT
79	1	-1.230 V	-1.500 V	
85	3	-860.0MV	-1.500 V	
91	5	-930.0MV	-1.500 V	
97	9	-960.0MV	-1.500 V	
103	11	-860.0MV	-1.500 V	
109	13	-860.0MV	-1.500 V	

-----  
FUNCTIONAL TEST  
VCC= 4.500  
VIH= 2 VIL= 700.0E-03  
-----

-----  
VOH TEST  
VCC= 4.500  
VOH LIMIT 2.500  
-----

INST #	PIN	MEASURED	LT	GT
194	2	3.040 V	2.500 V	
200	4	3.050 V	2.500 V	
206	6	3.050 V	2.500 V	
212	8	3.050 V	2.500 V	
218	10	3.050 V	2.500 V	
224	12	3.050 V	2.500 V	

-----  
VOL TEST  
VCC= 4.500  
VOL LIMIT 400.0E-03  
-----

INST #	PIN	MEASURED	LT	GT
244	2	264.0MV		400.0MV
250	4	242.0MV		400.0MV
256	6	248.0MV		400.0MV
262	8	254.0MV		400.0MV
268	10	262.0MV		400.0MV
274	12	246.0MV		400.0MV

```

-----
FUNCTIONAL TEST
VCC= 5.500
VIH= 2          VIL= 700.0E-03
-----

```

IOS TEST -20MA MIN, -100MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
300	2	-41.90MA	-100.0MA	-20.00MA
306	4	-44.00MA	-100.0MA	-20.00MA
312	6	-42.90MA	-100.0MA	-20.00MA
318	8	-42.70MA	-100.0MA	-20.00MA
324	10	-41.20MA	-100.0MA	-20.00MA
330	12	-44.00MA	-100.0MA	-20.00MA

IIH TEST 20UA MAXVIN= 2.7VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
346	1	-100.0NA		20.00UA
350	3	-100.0NA		20.00UA
354	5	-100.0NA		20.00UA
358	9	-100.0NA		20.00UA
362	11	-100.0NA		20.00UA
366	13	-100.0NA		20.00UA

II TEST 100UA MAXVIN=7.0VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
377	1	-100.0NA		100.0UA
381	3	-100.0NA		100.0UA
385	5	-100.0NA		100.0UA
389	9	-100.0NA		100.0UA
393	11	-100.0NA		100.0UA
397	13	-100.0NA		100.0UA

III TEST -400UA MAXVIN=0.4VVCC=5.5V

INST #	PIN	MEASURED	LT	GT
413	1	-190.0UA	-400.0UA	
417	3	-190.0UA	-400.0UA	
421	5	-190.0UA	-400.0UA	
425	9	-190.0UA	-400.0UA	
429	11	-190.0UA	-400.0UA	
433	13	-190.0UA	-400.0UA	

ICC TEST OUTPUT HIGH 2.4MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
451	14	1.320MA		2.400MA

ICC TEST OUTPUT LOW 6.6MA MAXVCC=5.5V

INST #	PIN	MEASURED	LT	GT
462	14	4.180MA		6.600MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS  EOT

```



# MIL-PRF-38534 CLASS K DATAPACK

---

Scanning Electron Microscopy (SEM) analysis



# TANDEX TEST LABS, INC.

15849 Business Ctr. Dr. Irwindale CA. 91706

Phone: (626)-962-7166 Fax: (626)-960-6896

## SCANNING ELECTRON MICROSCOPE ANALYSIS

DIE DEVICES

TTL Job # DDS-101-14-W

Date: June 28, 2018

Part Number: 54LS04

Part Type: SCHOTTKY LOGIC MICROCIRCUIT

Lot: Lot# 700654 D/C: 1810 WFR# 11

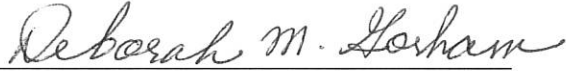
Quantity: Eight (8)

Purchase Order: SS139

Submitted by: \_\_\_\_\_

  
Jason A. Salinas  
DPA/MTS

Approved by: \_\_\_\_\_

  
Deborah M. Gorham  
Quality Assurance

## TANDEX TEST LABS TTL Job # DDS-101-14-W

Summary

Eight (8) Schottky Logic Microcircuit P/N: 54LS04 were submitted by Die Devices for Scanning Electron Microscopy Analysis. This Analysis was performed in accordance with Mil-Std-883, Method 2018.6 The devices were assigned sample number 1 through 8 by Tandex Test Labs.

1. **Plasma Etching** Carbon Tetrafluoride Gas 92% and 8% Oxygen was used to remove the glassivation. This etching is destructive and uneven in the rates of glass removal in various areas of the die.
2. **SEM Inspection** was performed on all eight devices. All eight devices revealed adequate metallization coverage and met the requirements of MIL-STD-883, Method 2018.6. See DPA form on page 3 and figures 1 through 3, for typical photographs.

**Conclusion:** This lot is acceptable for use.



TANDEX TEST LABS TTL Job # DDS-101-14-W  
SEM EXAMINATION

TTL Job No. DDS-101-14-W	Part Number 54LS04	Part Type Schottly Logic Microcircuit	Date June 27, 2018
Lot Date Code: WFR# 11 Lot# 80393 D/C: 1810	Sample Qty. 8	Serial Numbers 1 - 8	Test Specifications Mil-Std-883 Method 2018.6
Misc. ID No.	Qty. Accept 8	Qty. Reject 0	Qty. Suspect 0

**Notes:**

S/N	Investigation Findings / Comments	A/R/S
1	No Anomalies	A
2	No Anomalies	A
3	No Anomalies	A
4	No Anomalies	A
5	No Anomalies	A
6	No Anomalies	A
7	No Anomalies	A
8	No Anomalies	A

Each sample was inspected for the general metallization condition at a magnification between 1,000 X and 6,000 X over 25% of the total metallization (unless specified differently). Each sample was inspected from four (4) viewing directions at a magnification between 5,000 X and 20,000 X

Inspection required Yes:  No:  Devices constructed with expanded Metallization Yes:  No:

Sample Glassivated Yes:  No:  Dual Level Metallization Yes:  No:

Glassivation Removed Using: PLASMA ETCHING

Beam accelerating voltage 10kV to 20kV Viewing angle 45 deg



\_\_\_\_\_  
Technician Stamp:

TANDEX TEST LABS TTL Job # DDS-101-14-W

## Photodocumentation

TANDEX TEST LABS TTL Job # DDS-101-14-W

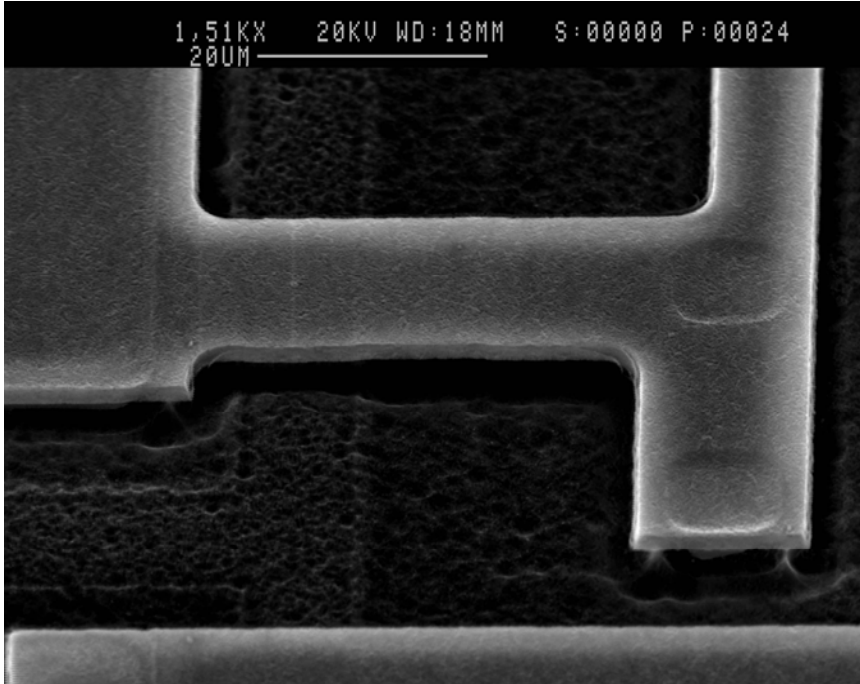


Fig: 1

Mag: 1,510X

S/N: 8

Description: SEM photograph of general metallization.

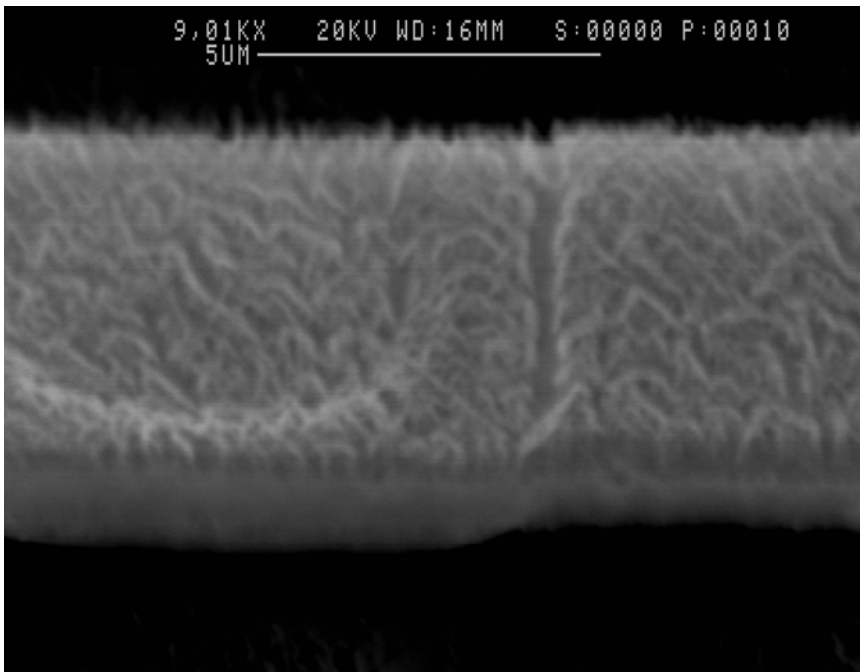


Fig: 2

Mag: 9,010X

S/N: 8

Description: SEM photograph of metallization typical step.

TANDEX TEST LABS TTL Job # DDS-101-14-W

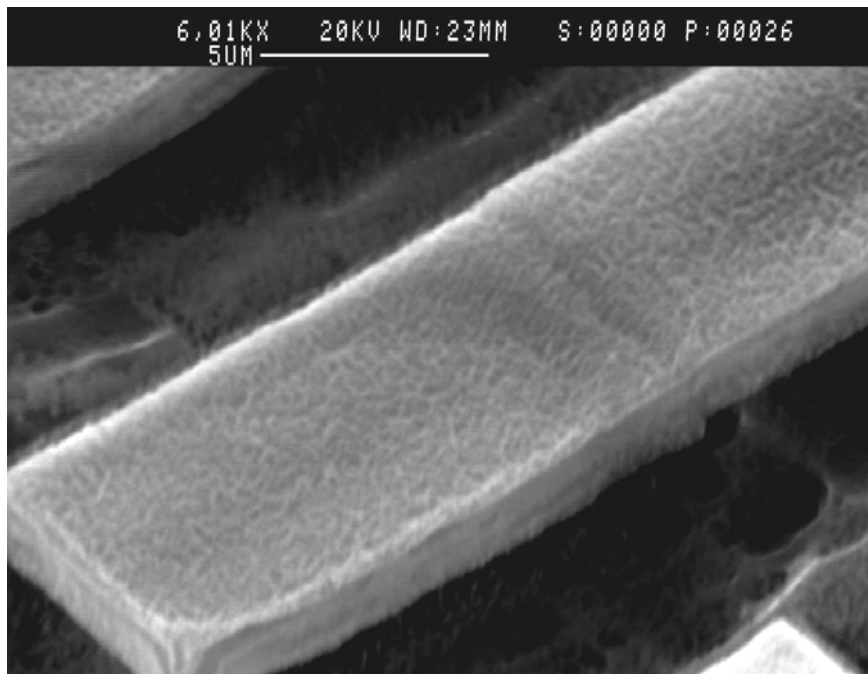


Fig: 3

Mag: 6,010X

S/N: 8

Description: SEM photograph of typical contact window device.

# TANDEX TEST LABS, INC.

15849 Business Center. Dr., Irwindale CA. 91706

Phone: (626)962-7166 FAX: (626)960-6896

<http://www.tandexlabs.com>

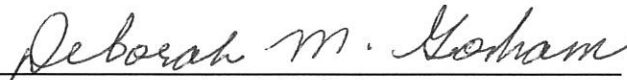
e-mail: via web site

## Certificate of Conformance

CUSTOMER:	Silicon Supplies Limited 47 Wherry Road  Norwich, NR1, 1WS United Kingdom Vat GB# 114 3513 56	DATE: June 28, 2018
TEST REPORT:	DDS-101-14-W	QUANTITY REQUIRED: 8
P.O. NUMBER:	SS139	QUANTITY PROCESSED: 8
DESCRIPTION:	SCHOTTKY LOGIC MICROCIRCUIT	QUANTITY PASSED: 8
PART NUMBER(S):	54LS04	QUANTITY FAILED: 0
MFG PART NUMBER	54LS04	QUANTITY SHIPPING: 8
LOT / DATE CODE:	LOT# 700654 WFR# 11 D/C: 1810	
MFG:	SILICON SUPPLIES	

METHOD OF TESTING: MIL-STD-883 METHOD 2018.6

I hereby certify that the subject components have been processed and inspected in accordance with instructions with specifications referenced in your purchase order. Physical records and/or data pertinent to applicable military, proprietary, and/or commercial specifications are on file and available upon request for inspection at this facility.





Deborah M. Gorham  
QUALITY ASSURANCE